

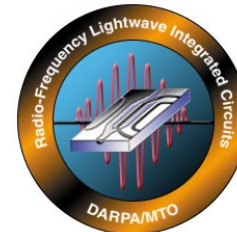
# Highly Efficient RF Lightwave Integrated Transmitters

**Contract DAAD17-01-C-0077**

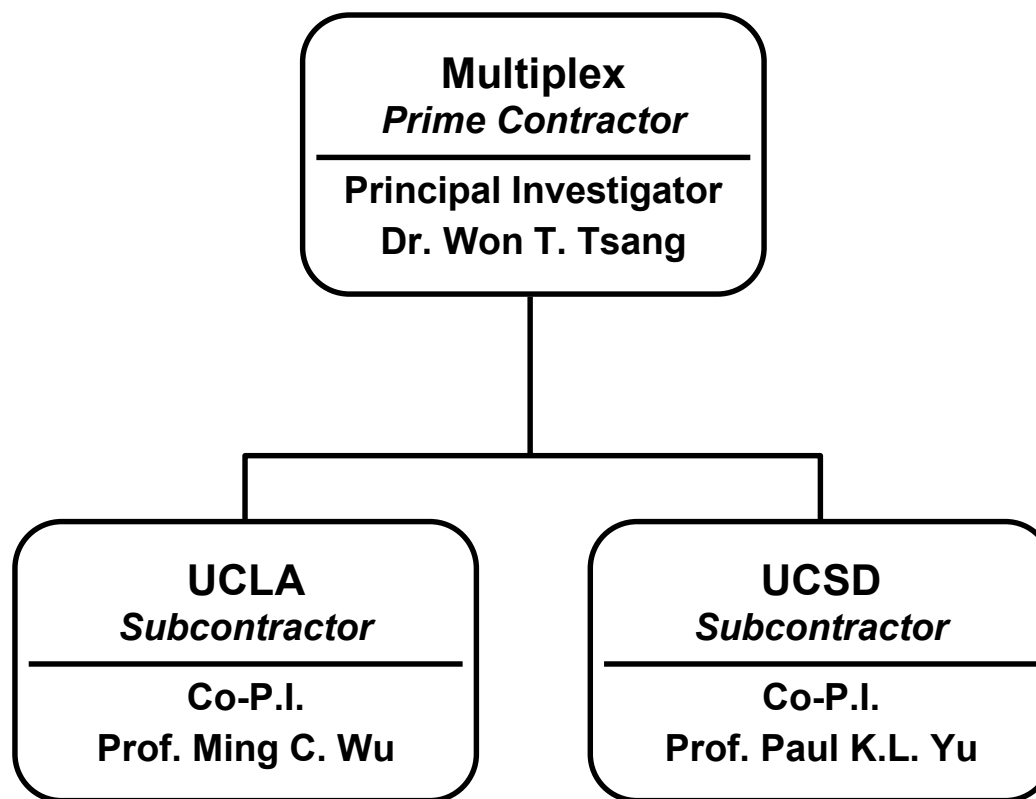
**RFLICS PI Review**

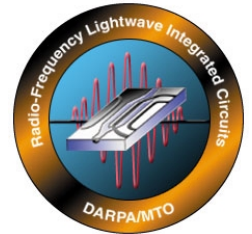
**El Segundo, CA 7/31/01**

**Dr. Won T. Tsang (Dr. Randall Wilson – presenting)**



# Team Management

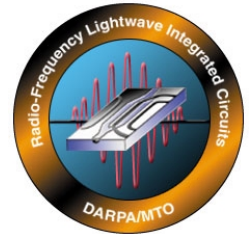




## RFLICS Goals

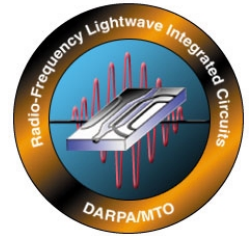
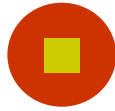
**Develop the key components for a RF-photonic link that meets the following specifications:**

- **Transmit/process RF signal in the 0.5-50GHz range**
- **Broadband (>40GHz)**
- **High spurious-free dynamic range (SFDR >100dB-Hz<sup>2/3</sup>)**
- **Low loss or with RF gain (>-1dB)**
- **Monolithically integratable for low cost.**

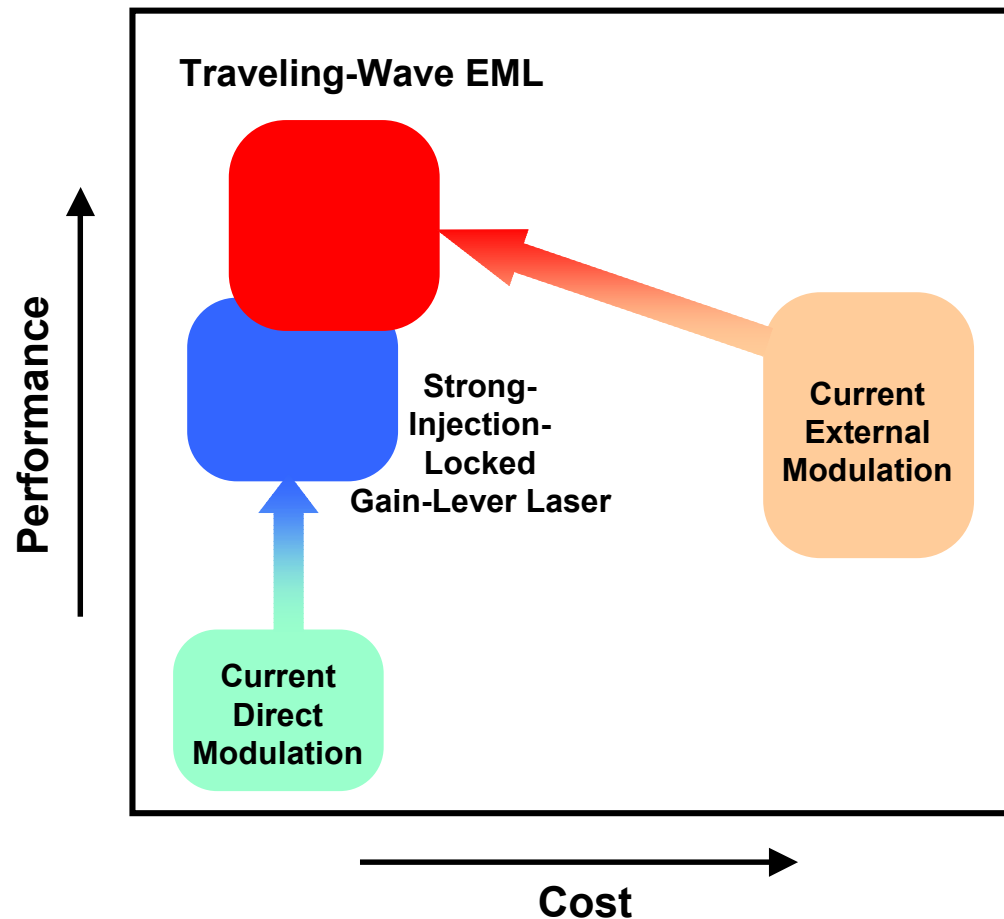


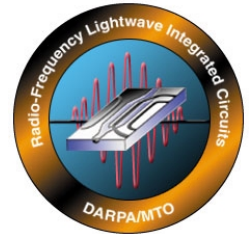
# Multiplex/UCLA/UCSD Program Goals

- **Traveling-Wave Electroabsorption-Modulated Laser Modules (TW-EML):**
  - Develop low- $V_{pi}$  ( $<0.5V$ ), broadband ( $>40GHz$ ) traveling-wave semiconductor electroabsorption modulators (EAM).
  - Monolithically integrate with distributed feedback (DFB) lasers using selective-area growth (SAG) by metal organic chemical vapor deposition (MOCVD).
- **Optical Injection Locking of Gain-lever Laser Modules:**
  - Develop a RF-phonic transmitter link by combining strong optical injection locking with gain-lever modulation.
  - Enhance the direct modulation bandwidth to achieve  $>40GHz$  operation.
  - Improve the RF modulation efficiency by 20dB (link gain improved by 40dB).
  - Reduce relative intensity noise (RIN) of the laser by 10 to 20 dB by using strong optical injection locking.



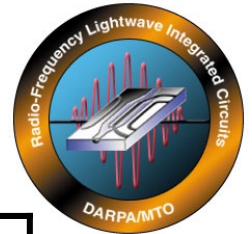
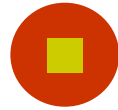
# Objective of RF-Lightwave Integrated Transmitters (RFLIT)





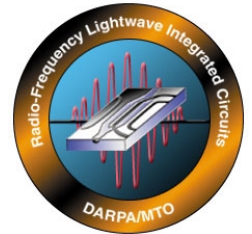
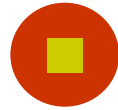
# Program Roadmap

Federal Government Fiscal Year	FY'01				FY'02				FY'03				FY'04				FY'05			
Calendar Year	2001				2002				2003				2004				2005			
Task Name	Q1	Q2	Q3	Q4	Q1	Q2	Q3	Q4	Q1	Q2	Q3	Q4	Q1	Q2	Q3	Q4	Q1	Q2	Q3	Q4
<b>1.0 Travelling Wave EML</b>																				
1.1 EML on SI Substrate Development							◆ 1													
1.2 Travelling Wave EML Development							◆ 2													
1.3 Low Vpi Modulator Development							◆ 3													
1.4 High Frequency Package Development									◆ 4											
1.5 Traveling Wave-EML Link Characterization															◆ 5			◆ 6		
<b>2.0 Optical Injection Locking of Gain-Lever Laser Dev.</b>																				
2.1 Gain-Level DFB Laser Development						◆ 7														
2.2 Tunable DFB Laser Development							◆ 8													
2.3 Optical Injection Locking									◆ 9											
2.4 Direct Modulation Laser Package Development									◆ 10											
2.5 Direct Mod. Characterization with Strong Inj. Locking													◆ 11					◆ 12		

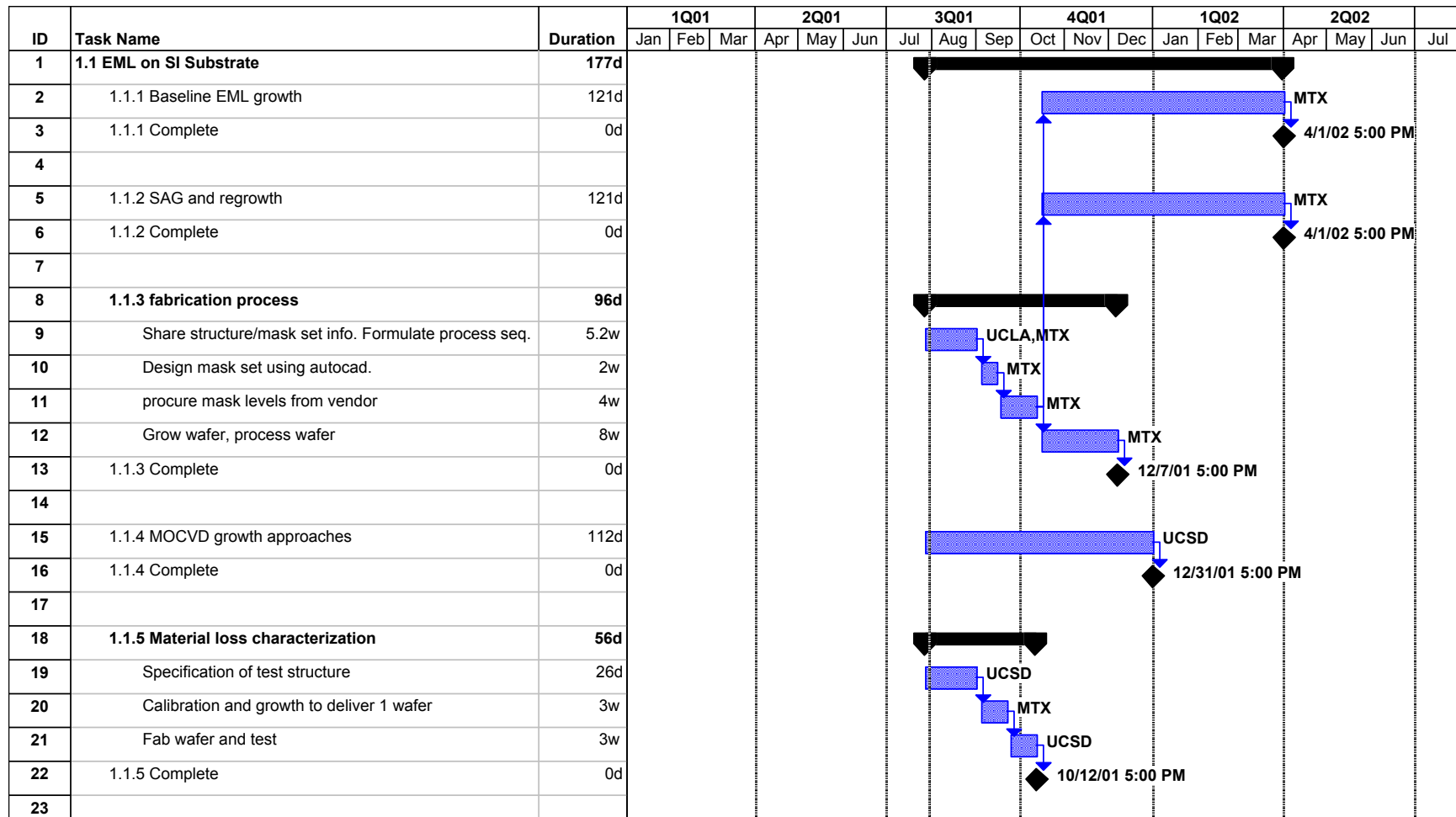


# Milestones and Deliverables

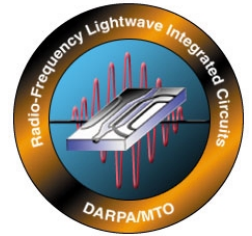
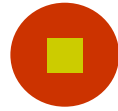
Milestone	Task	Milestone/Deliverable
1	1.1	Complete development of baseline EML technology on SI-InP
2	1.2	Complete development of 1 <sup>st</sup> generation TW-EML
3	1.3	Complete development of 1 <sup>st</sup> generation TW-EML with low V <sub>pi</sub>
4	1.4	TW-EML high frequency package complete. Link characterization of 1 <sup>st</sup> gen TW-EML complete. Deliver alpha prototype TW-EML
5	1.5	Link characterization of 2 <sup>nd</sup> gen TW-EML complete. Deliver beta prototype TW-EML
6	1.5	Link characterization of 3 <sup>rd</sup> gen TW-EML complete. Deliver final prototype TW-EML
7	2.1	Complete development of 1 <sup>st</sup> generation Gain-Lever DFB
8	2.2	Complete development of 1 <sup>st</sup> generation Tunable DFB
9	2.3	Package development for high frequency Gain-Lever laser complete
10	2.4	Optical injection locking experiment complete using 1 <sup>st</sup> gen components from milestones 7 and 8.
11	2.5	Link characterization of optical injection locked Gain-Level DFB laser. Deliver beta prototype.
12	2.5	Link characterization of 2 <sup>nd</sup> gen optical injection locked Gain-Lever DFB. Deliver final prototypes.



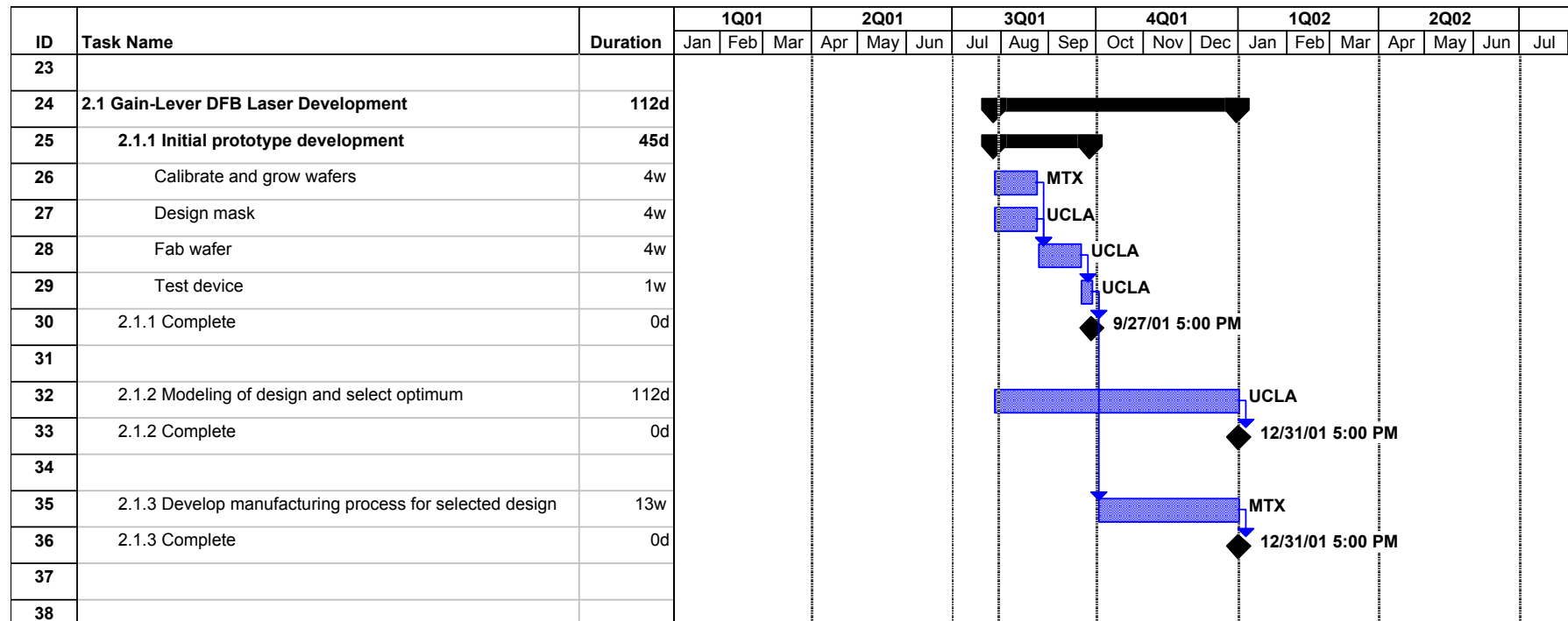
# Task 1.1 Detailed Schedule/Milestones

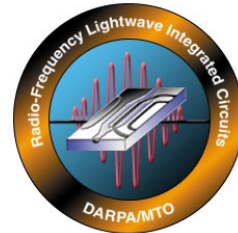
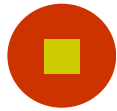






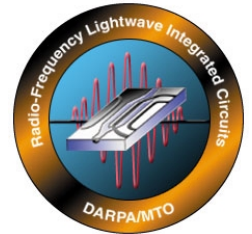
## Task 2.1 Detailed Schedule/Milestones





## Most Significant Accomplishment

- **Contract Awarded June 6, 2001**
- **Traveling Wave Electro-Optical Models at both UCLA and UCSD are operational and are producing favorable results and predictions ready to be compared with experiment.**



# RFLIT: Electroabsorption Modulator for Broadband Access

*Paul Yu -UCSD*

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## A. Is there traveling-wave effect in short device?

Traveling wave model

How the traveling-wave model migrates to lumped-element model

How to break the RC-bandwidth-limit rule by TW-EAM design

## B. The design and performance of TW-EAM devices fabricated at UCSD

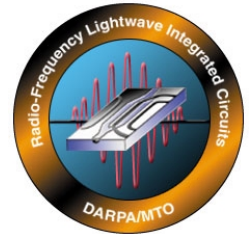
Device structure

Microwave properties of the waveguide

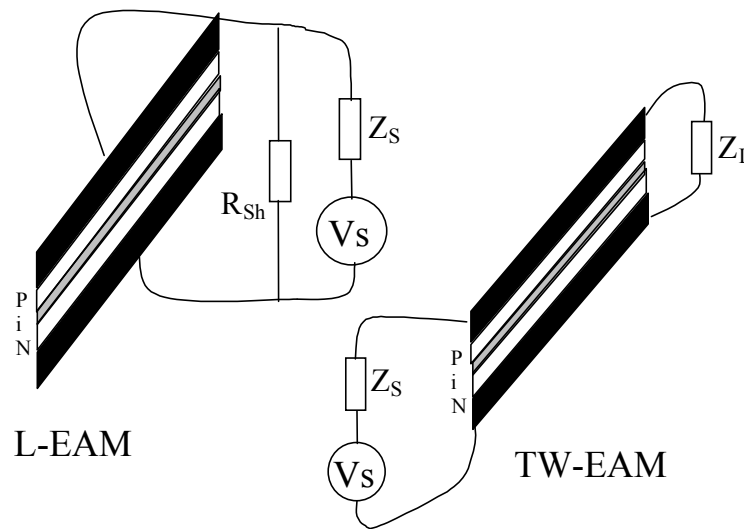
Modulation frequency response and bandwidth

Optical saturation power

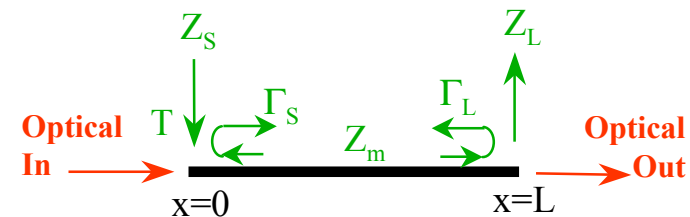
## C. Current Investigation



## Electrical Connections of L-EAM and TW-EAM



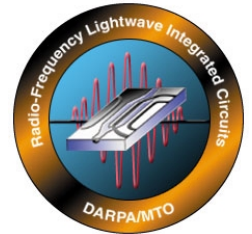
To achieve maximum link RF gain,  
the best waveguide length has been  $\sim 200 \mu\text{m}$   
(limited by optical propagation loss)



Both are  $\sim 200 \mu\text{m}$  long.

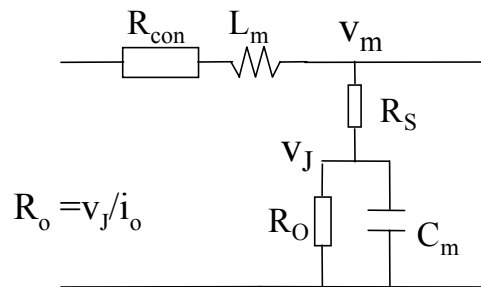
Are there any advantages for the  
electrical connection to TW-EAM ?

$$\Gamma_S = \frac{Z_S - Z_m}{Z_S + Z_m} \quad \Gamma_L = \frac{Z_L - Z_m}{Z_L + Z_m} \quad T = \frac{2Z_m}{Z_S + Z_m} = 1 - \Gamma_S$$



## Circuit Model for TW-EAM

**Small-segment lumped-element circuit model for TW-EAM transmission line.**



$$Z_{\text{series}} = R_{\text{con}} + j\omega L_m$$

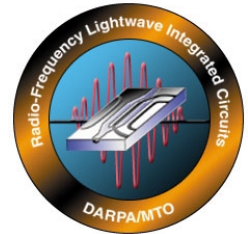
$$Z_{\text{shunt}} = R_S + \frac{R_O}{1 + j\omega R_O C_m}$$

$$Z_m = \sqrt{Z_{\text{series}} Z_{\text{shunt}}} \quad \gamma_\mu = \alpha_\mu + j\beta_\mu = \sqrt{\frac{Z_{\text{series}}}{Z_{\text{shunt}}}}$$

**Modified TW-EAM  
frequency response :**

$$M'(f) = M(f) \left| \frac{Z_{\text{junc}}}{Z_{\text{shunt}}} \right|^2$$

$$Z_{\text{junc}} = \frac{R_O}{1 + j\omega R_O C_m}$$



## From TW-EAM to L-EAM

$$M(f) = \left| \frac{T}{e^{\gamma_\mu L} - \Gamma_L \Gamma_S e^{-\gamma_\mu L}} \left\{ \frac{e^{j\beta_o L} - e^{\gamma_\mu L}}{(j\beta_o - \gamma_\mu)L} + \Gamma_L \frac{e^{j\beta_o L} - e^{-\gamma_\mu L}}{(j\beta_o + \gamma_\mu)L} \right\} \times \frac{Z_{junc}}{Z_{shunt}} \right|^2$$

**For L-EAM:**

$\Gamma_L = 1$ ,  
 $L$  is very short.

$$= \left| \frac{T}{e^{\gamma_\mu L} - \Gamma_S e^{-\gamma_\mu L}} \{1 + 1\} \times \frac{Z_{junc}}{Z_{shunt}} \right|^2 = \left| \frac{2(1 - \Gamma_S)}{(1 - \Gamma_S) + \gamma_\mu L(1 + \Gamma_S)} \times \frac{Z_{junc}}{Z_{shunt}} \right|^2$$

$$T = 1 - \Gamma_S$$

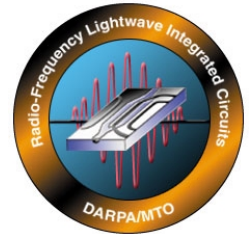
$$= \left| \frac{2Z_{junc}}{Z_{shunt} + LZ_S} \right|^2$$

$$\frac{1 + \Gamma_S}{1 - \Gamma_S} = \frac{Z_S}{Z_m} \quad \frac{\gamma_\mu}{Z_m} = \frac{1}{Z_{shunt}}$$

$$= \left| \frac{2}{1 + j\omega C_m L(Z_S + R_S/L)} \right|^2$$

Assume  $Z_{junc} = \frac{1}{j\omega C_m}$   $Z_{shunt} = R_S + \frac{1}{j\omega C_m}$

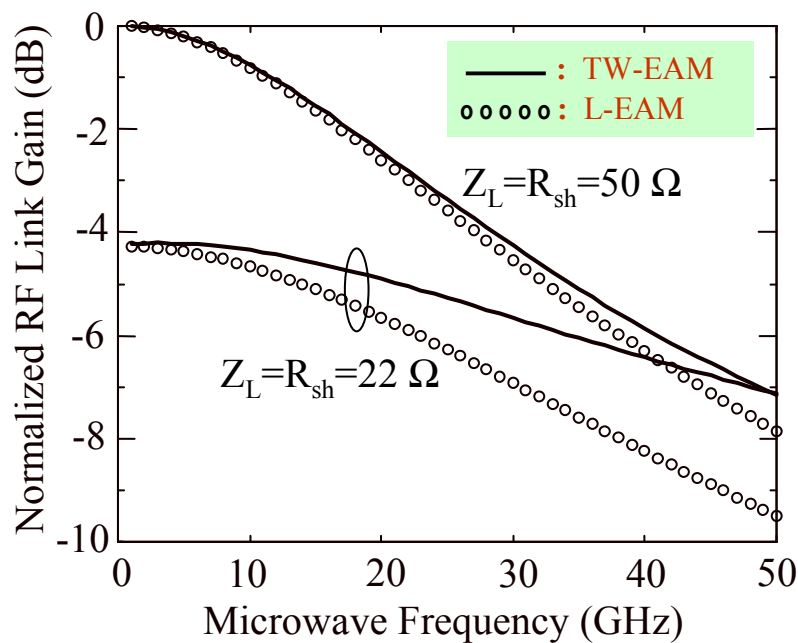
- 1). L-EAM means both short-length and open-termination,
- 2). Proper termination for short TW-EAM could break RC-limit rule for bandwidth,
- 3). Velocity-matching is not very important.



## Breaking the RC-Limit Rule for Modulation Bandwidth

Comparing L-EAM and TW-EAM with **the same optical waveguides**:

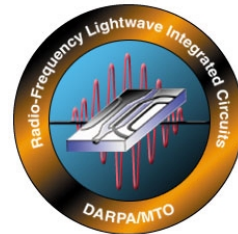
$L=0.2\text{mm}$ ,  $L_m=0.5\text{ nH/mm}$ ,  $C_m=1.2\text{ pF/mm}$ ,  $R_{\text{con}}=3.5\text{ }\Omega\text{-mm}^{-1}\text{GHz}^{-1/2}$ ,  $R_s=1\text{ }\Omega\text{-mm}$ ,  $R_o=10^6\text{ }\Omega\text{-mm}$ ,  $n_o=3.5$



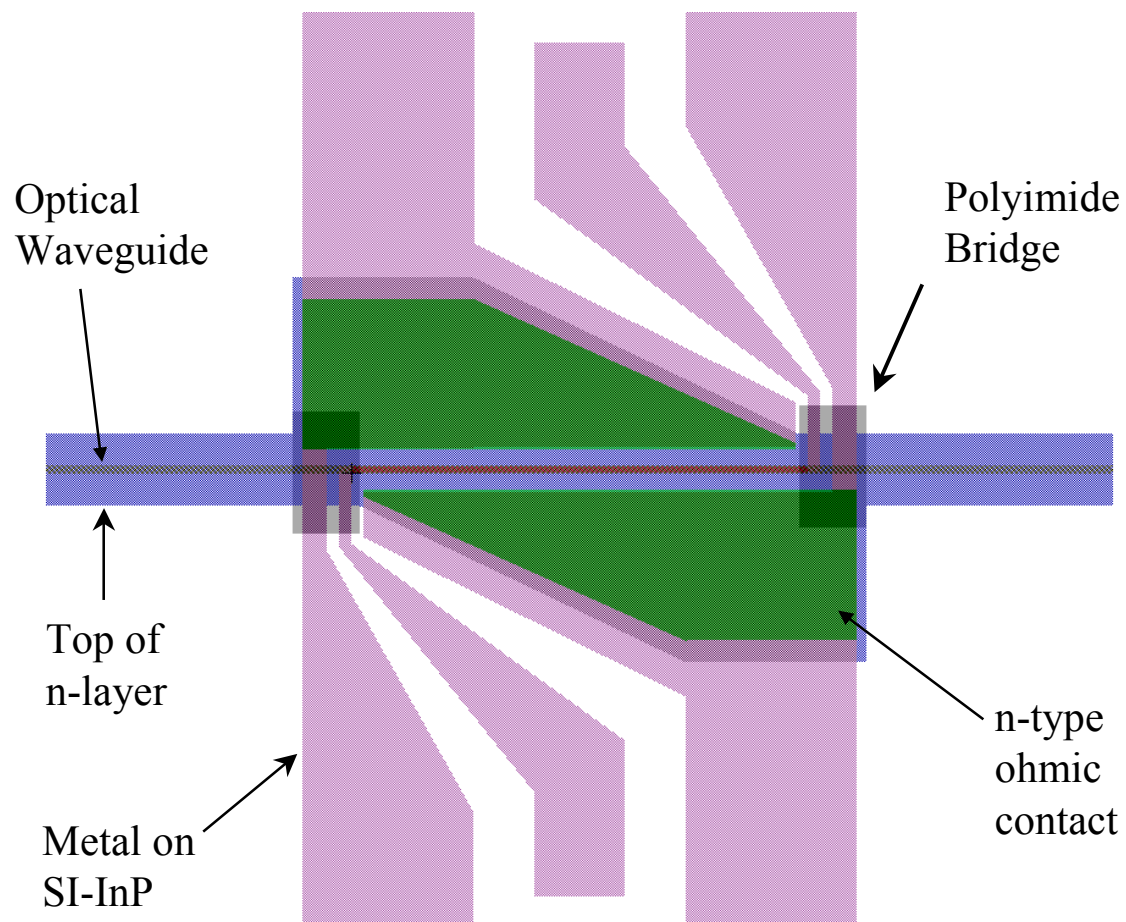
**3-dB bandwidth:**

	$Z_L=R_{sh}=50\text{ }\Omega$	$Z_L=R_{sh}=22\text{ }\Omega$
L-EAM	20 GHz	30 GHz
TW-EAM	21 GHz	50 GHz

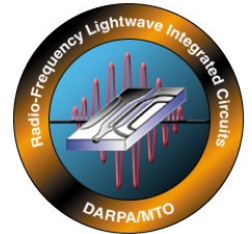
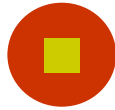
Low impedance termination  
for TW-EAM can break the  
RC-limit rule for bandwidth



## Device Top View





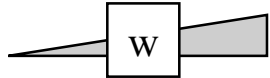


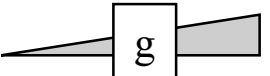
## Device Design: Cross-section

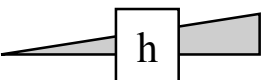
FKE device with large optical cavity

w and d are determined for  
maximum modulation efficiency.

$w \sim 3 \mu\text{m}$ ,  $d \sim 0.35 \mu\text{m}$   
 $g \sim 5\text{--}10 \mu\text{m}$ ,  $h \sim 2 \mu\text{m}$

Larger  $L_m$   smaller  $R_{\text{con}}$

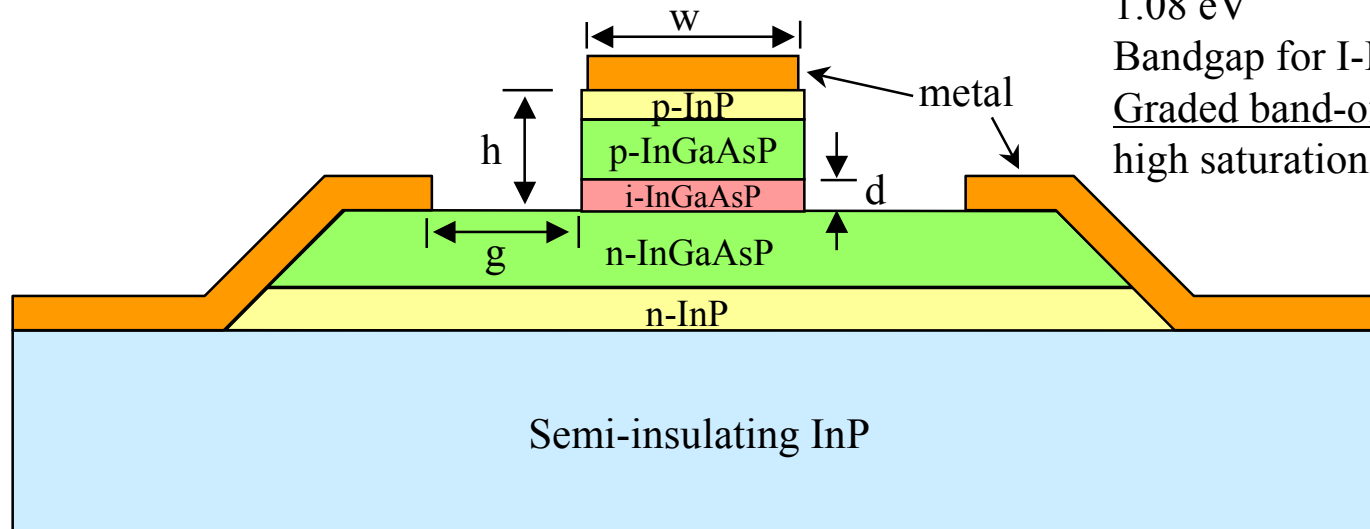
smaller  $R_s$   Larger  $L_m$

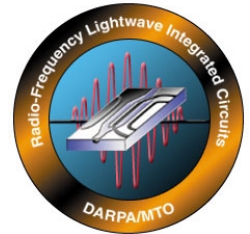
smaller  $R_s$   Larger  $L_m$

Bandgap for p- and n-InGaAsP:  
1.08 eV

Bandgap for I-InGaAsP: 1.00 eV

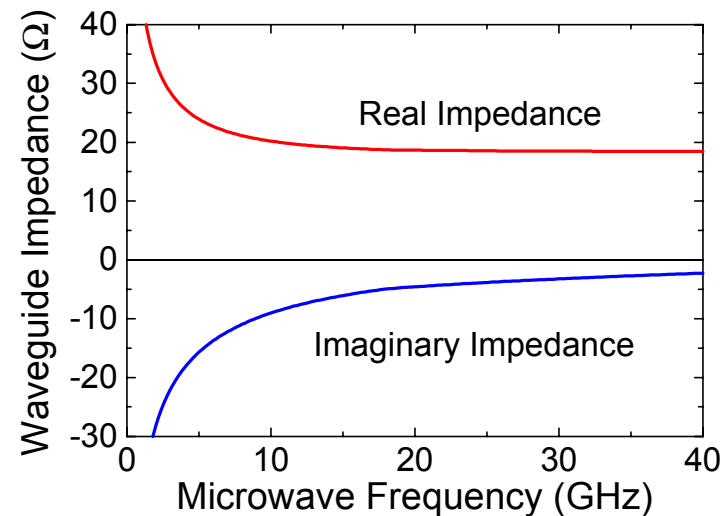
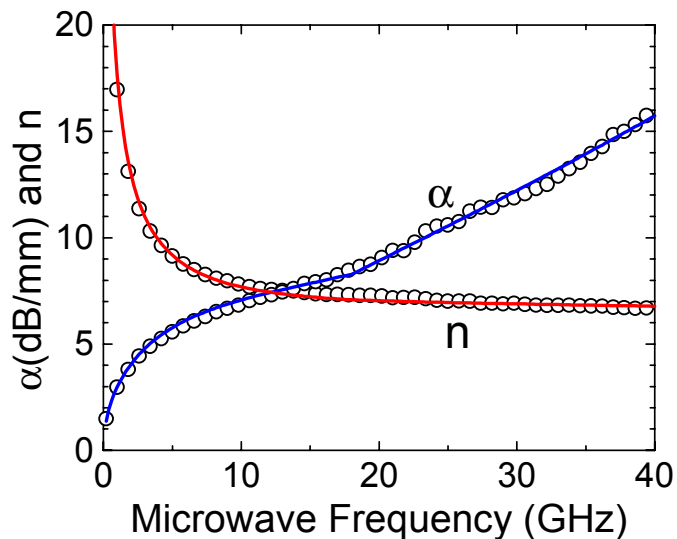
Graded band-offset is good for  
high saturation





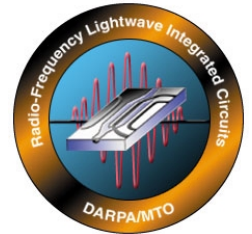
## Waveguide Microwave Properties

For the fabricated TW-EAM device



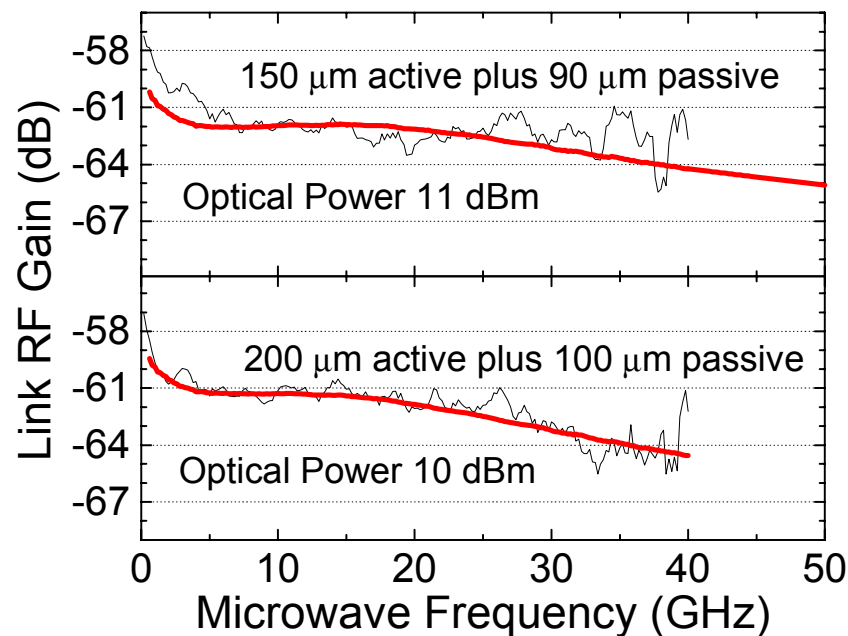
De-embedded circuit parameters from curves of  $\alpha(f)$  and  $n(f)$  :

$L_m \sim 0.40$  nH/mm,  $C_m \sim 1.3$  pF/mm,  $R_{con} \sim 7.3 \Omega\text{-mm}^{-1}\text{-GHz}^{-1/2}$ ,  $R_s \sim 0.58 \Omega\text{-mm}$ .



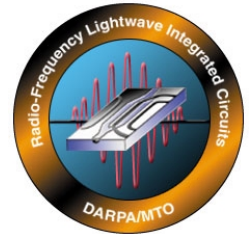
# Device Frequency Response

Termination impedance  $26.2 \Omega$ . Detector RF responsivity  $\sim 0.12 \text{ A/W}$  up to 40 GHz.

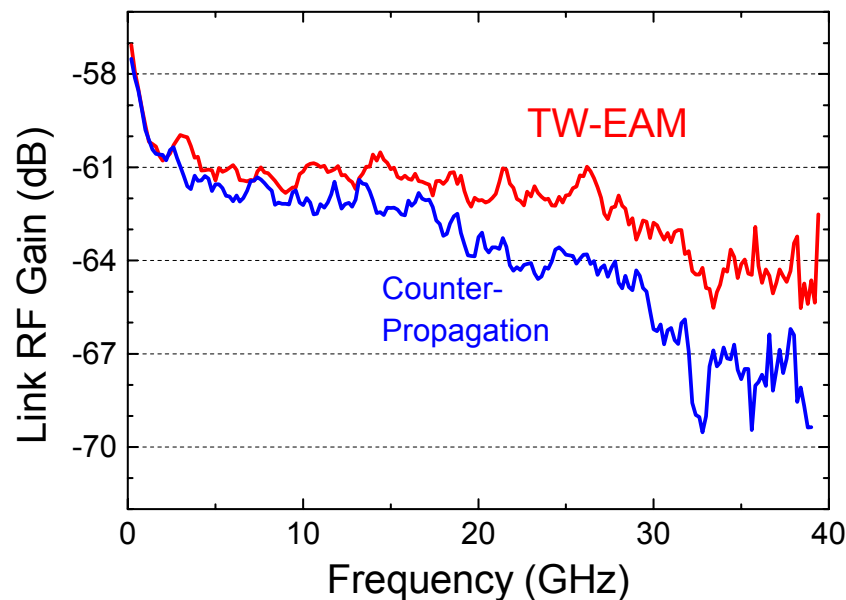


For 200  $\mu\text{m}$  long L-EAM with the same optical waveguide:

$C_m \sim 1.3 \times 0.2 = 0.26 \text{ pF}$ ,  $R_s \sim 0.58 / 0.2 = 3 \Omega$ ,  $R_{sh} = 26.2 \Omega$   
Assume 0.03 pF capacitance due to bonding pad.  
**Modulation bandwidth  $\sim 25 \text{ GHz}$**



# Counter-Propagation Measurement



200  $\mu\text{m}$  long active length  
plus 100  $\mu\text{m}$  long passive length

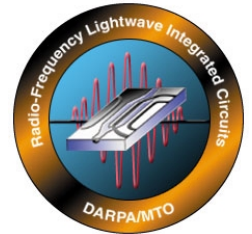
Input optical power: 11.5 dBm

Detector RF responsivity:  
 $\sim 0.20$  A/W up to 40 GHz

Modulator optical loss: 11.5 dB

From 5 GHz, 3-dB cut-off :  
at 25 GHz for blue curve  
at 36 GHz for red curve

$$M(f) = \left| \frac{T}{e^{\gamma_{\mu}L} - \Gamma_L \Gamma_S e^{-\gamma_{\mu}L}} \left\{ \frac{e^{j\beta_o L} - e^{\gamma_{\mu}L}}{(j\beta_o - \gamma_{\mu})L} + \Gamma_L \frac{e^{j\beta_o L} - e^{-\gamma_{\mu}L}}{(j\beta_o + \gamma_{\mu})L} \right\} \times \frac{Z_{junc}}{Z_{shunt}} \right|^2$$



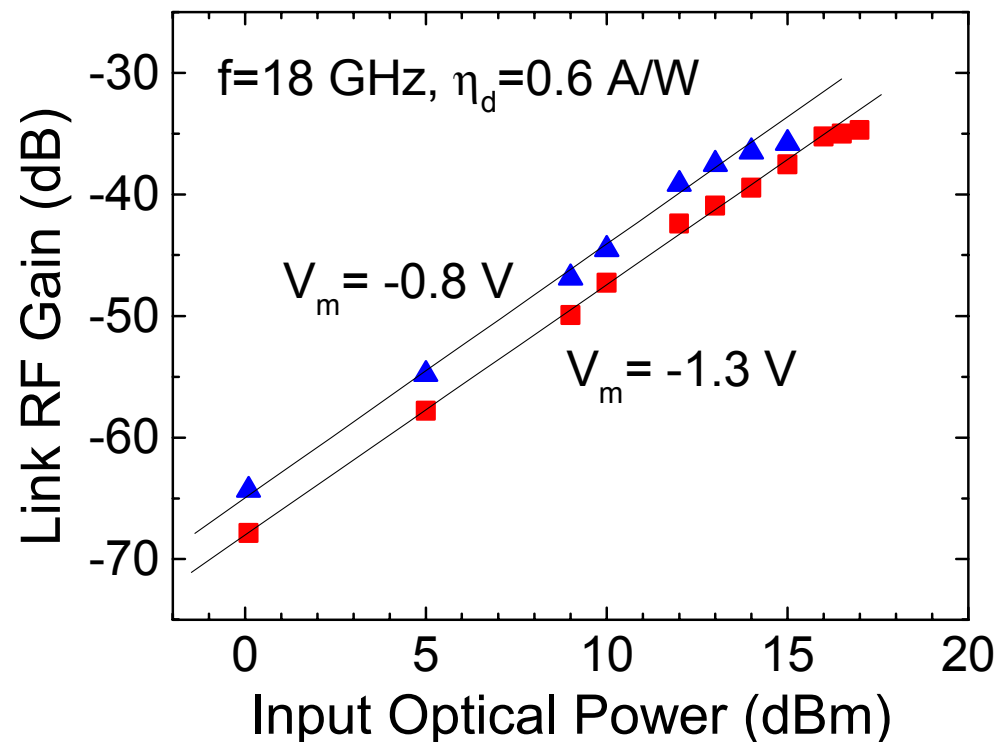
# Optical Saturation Measurement

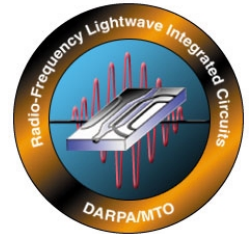
Two devices shown:  
200  $\mu\text{m}$  long modulation length  
plus 100  $\mu\text{m}$  long passive section.

26.2  $\Omega$  termination.

optical saturation power @  
1-dB gain compression point:

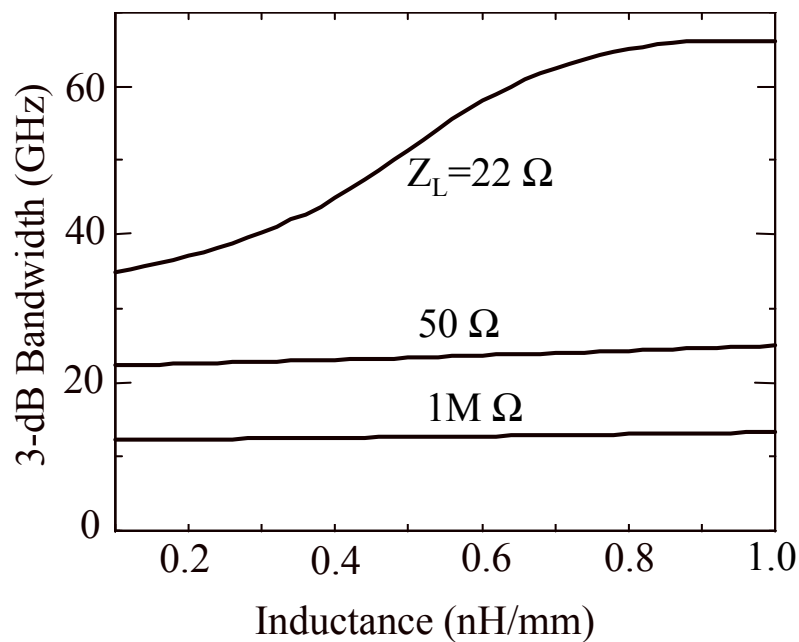
25 mW and 45 mW respectively



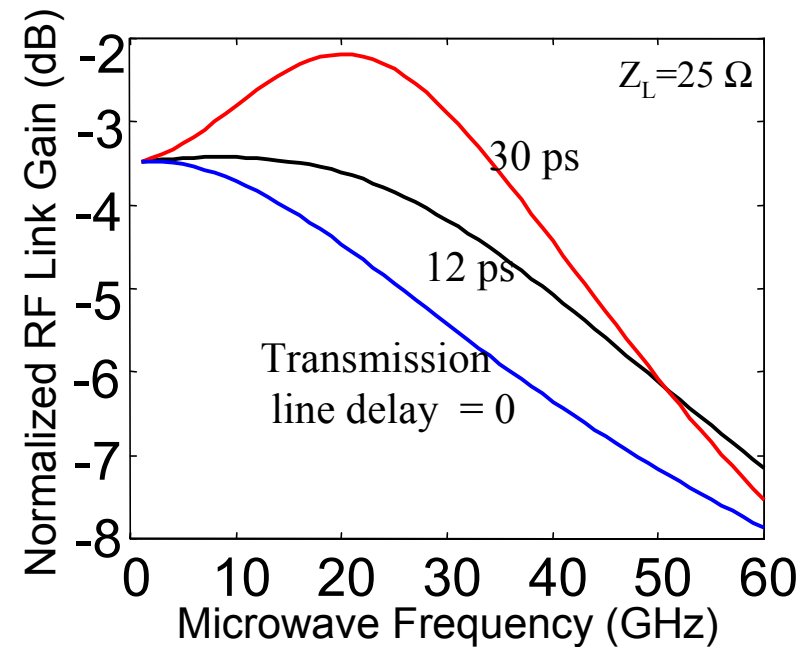


## Current Investigations for TW-EAM with Larger Bandwidth

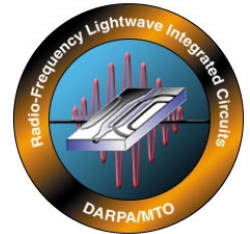
*a. Increasing Waveguide Inductance*



*b. Design Terminator Transmission Line*



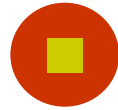
Inductance is  $<1$  nH/mm for an usual TW-EAM.



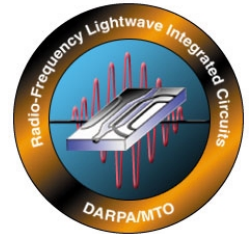
## Summary

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1. Traveling-wave design can improve performance for short device.
2. Low impedance termination for TW-EAM can break the RC-limit rule for the bandwidth.
3. The fabricated TW-EAM devices show good performance.  
bandwidth > 40 GHz,  
optical saturation power ~45 mW.
4. Current Investigation underway for low  $V_{\pi}$ , large bandwidth EA modulator design for Traveling wave EML.



***RF Lightwave Integrated Circuits (R-FLICS) PI Meeting***  
***July 31, 2001***



# **Highly Efficient RF Lightwave Integrated Transmitters (RFLIT)**

**Ming C. Wu, UCLA**

**Graduate Students:**

**Sagi Mathai, Juthika Basak, Tom Jung, Erwin Lau**

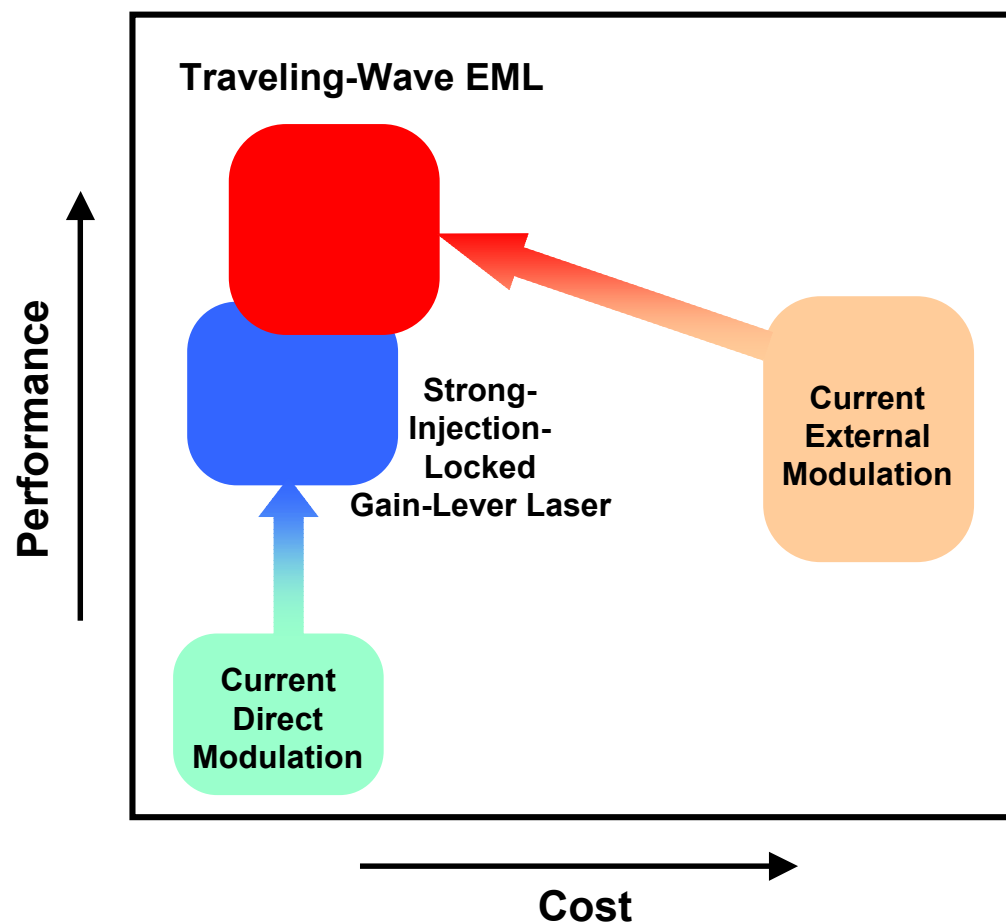
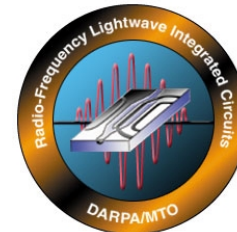
**Collaboration:**

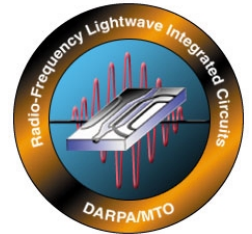
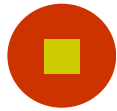
**Federica Cappelluti, Prof. Giovanni Ghione  
Politecnico di Torino, Italy**





# Objective of RF-Lightwave Integrated Transmitters (RFLIT)

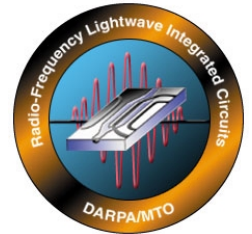




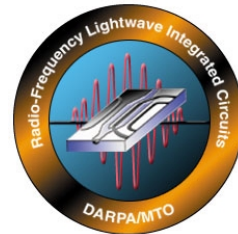
# Program Goals

- **Team Goal:**
  - Develop chip-scale RF Lightwave Integrated Transmitters (RFLIT) for high performance military and commercial RF systems:
- **UCLA Goal:**
  - **Traveling-wave EML:**
    - Design and modeling of EML
    - Assist in fabrication of prototype EML
  - **Directly modulation with strong optical injection locking**
    - Enhance bandwidth with strong optical injection locking
    - Enhance efficiency with split-contact (gain-lever) modulation
    - Comprehensive modeling
    - Fabrication and experimental demonstration

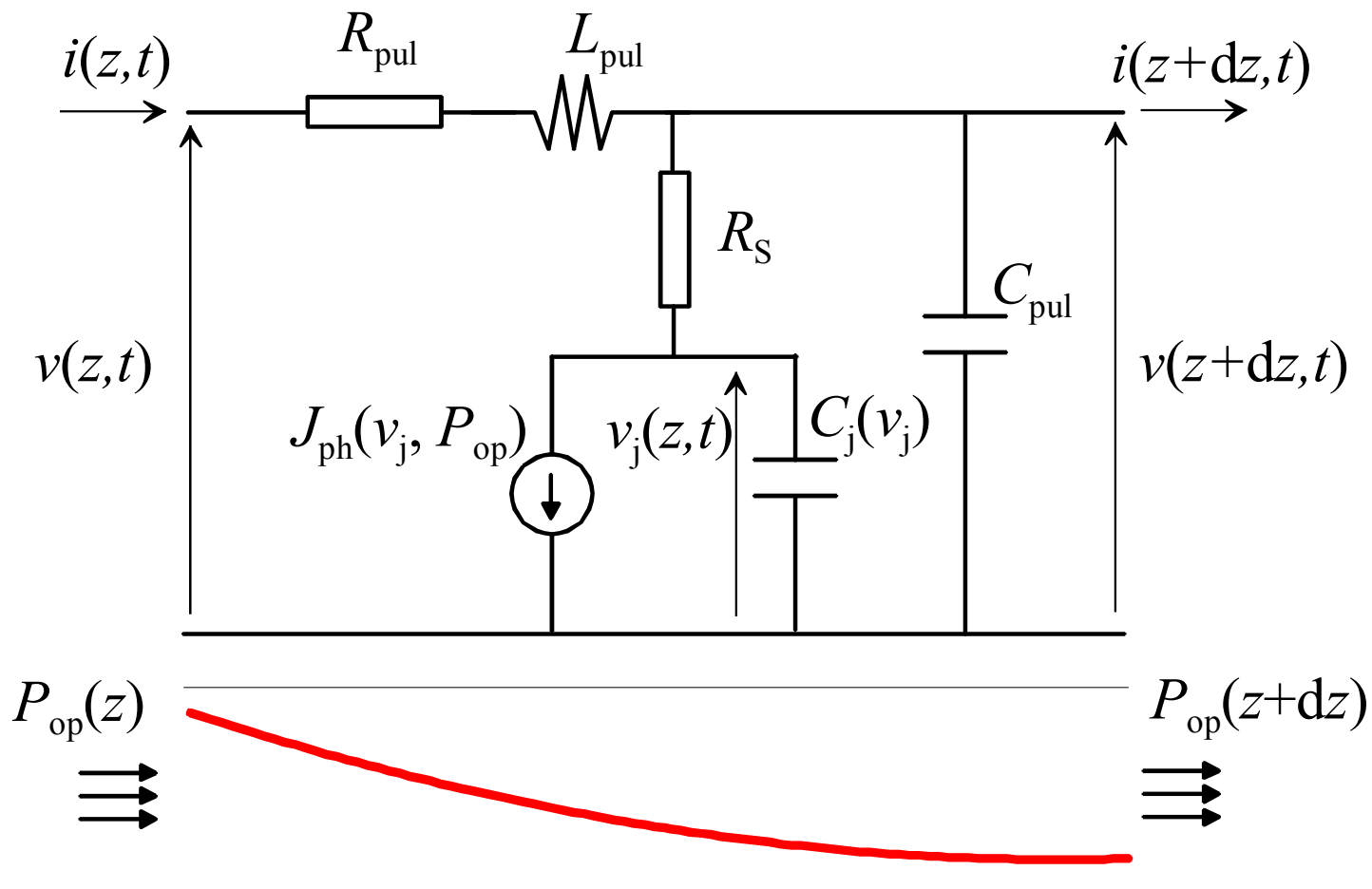
# Self-Consistent Time-Domain Large Signal of TW-EAMs

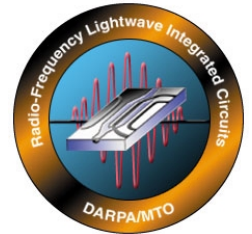


- TW-EAMs models proposed so far are derived in quasi-static conditions and exploit linear approximations of microwave and optical parameters.
- Several **nonlinear** effects take place in TW-EAMs:
  - Absorption is a nonlinear function of applied voltage
  - Photocurrent causes non-uniform microwave losses and saturates at high optical power
  - Propagation characteristics of the microwave electrodes depend on the applied voltage through the photocurrent and, to a lesser extent, through the nonlinear junction capacitance
- Frequency-domain linear models cannot account for the RF and optical power induced nonlinear behavior, even at a small signal level



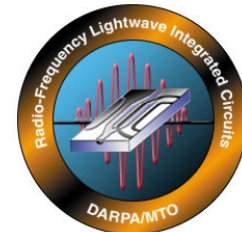
# The Dynamic TW-EAM Model (I)





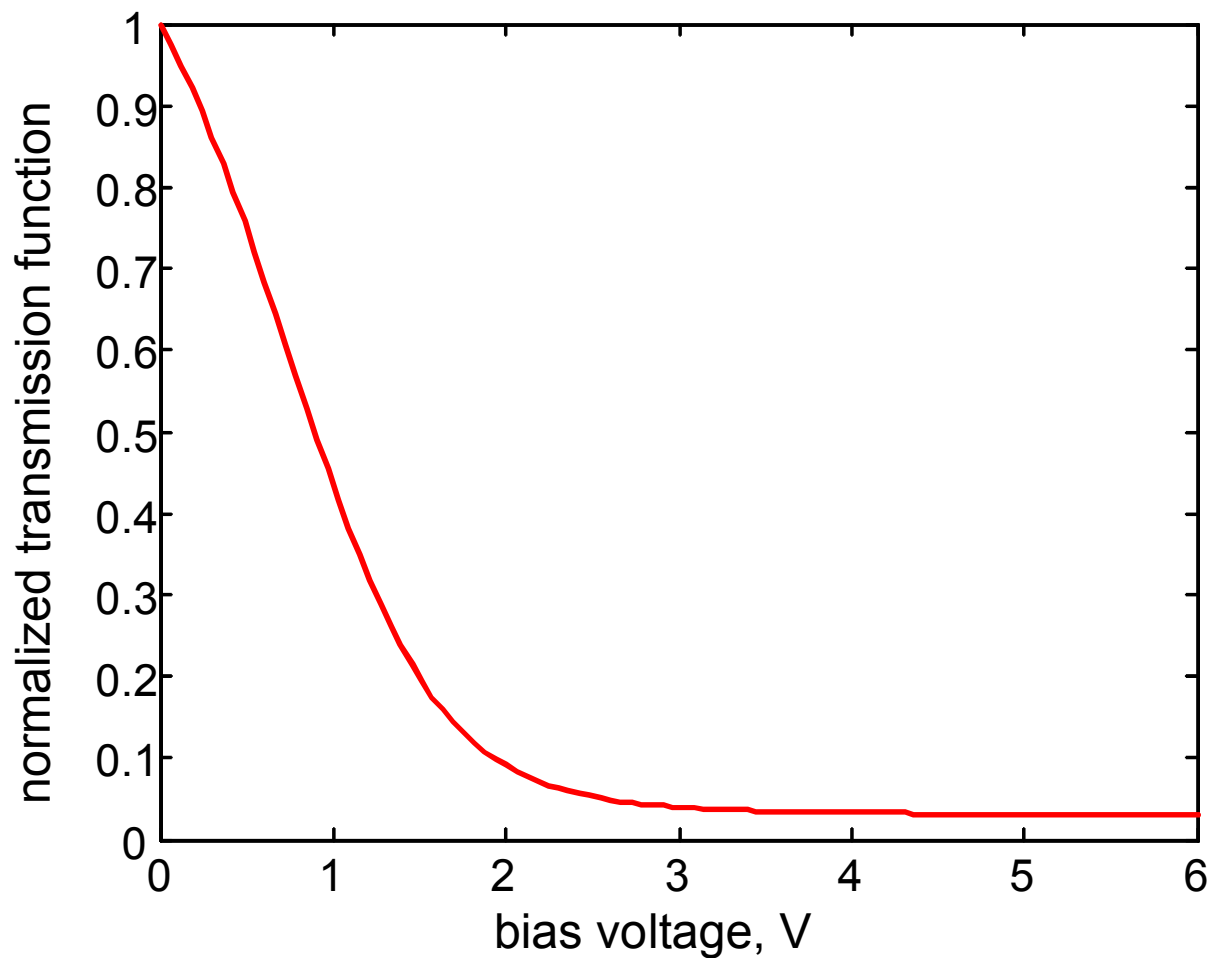
## The Dynamic TW-EAM Model (II)

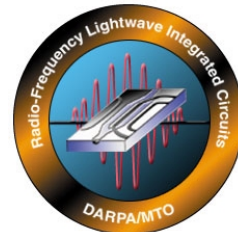
- Microwave and optical fields propagation equations coupled through:
  - voltage and optical power dependence of the photogenerated current
  - microwave losses induced from the photogenerated current
- Empirical formulas were used for the voltage and optical power dependence of the absorption
- Coupled equations implemented in the **time domain**
- Numerical solution of the equations obtained following a first order finite difference approach
- System solved **self-consistently** through a semi-implicit method



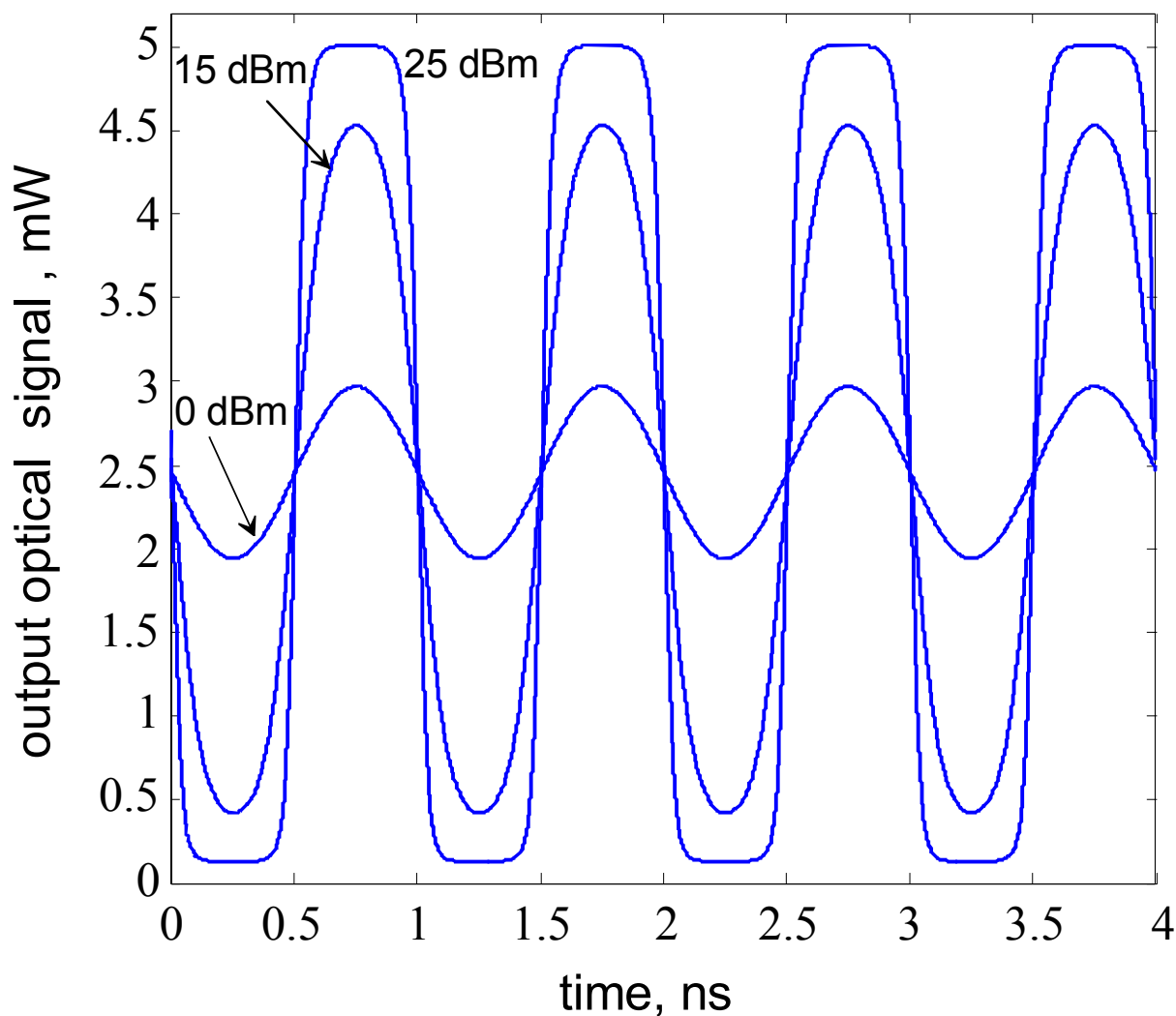
# Results

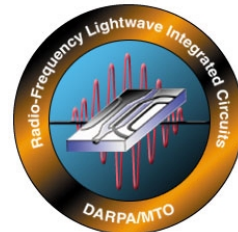
- Simulations performed on a 200  $\mu\text{m}$  long EAM:



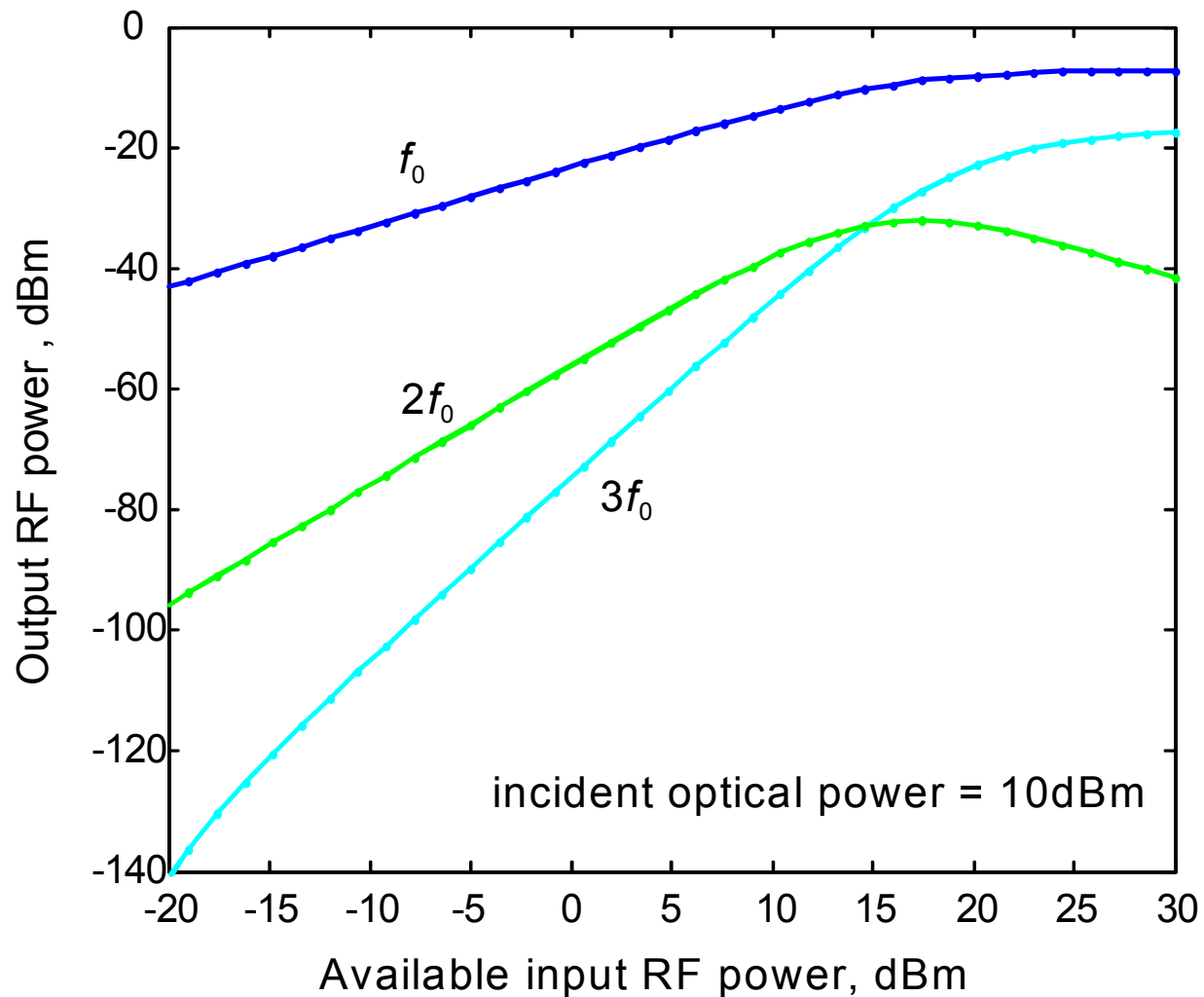


# Time Domain Optical Waveforms





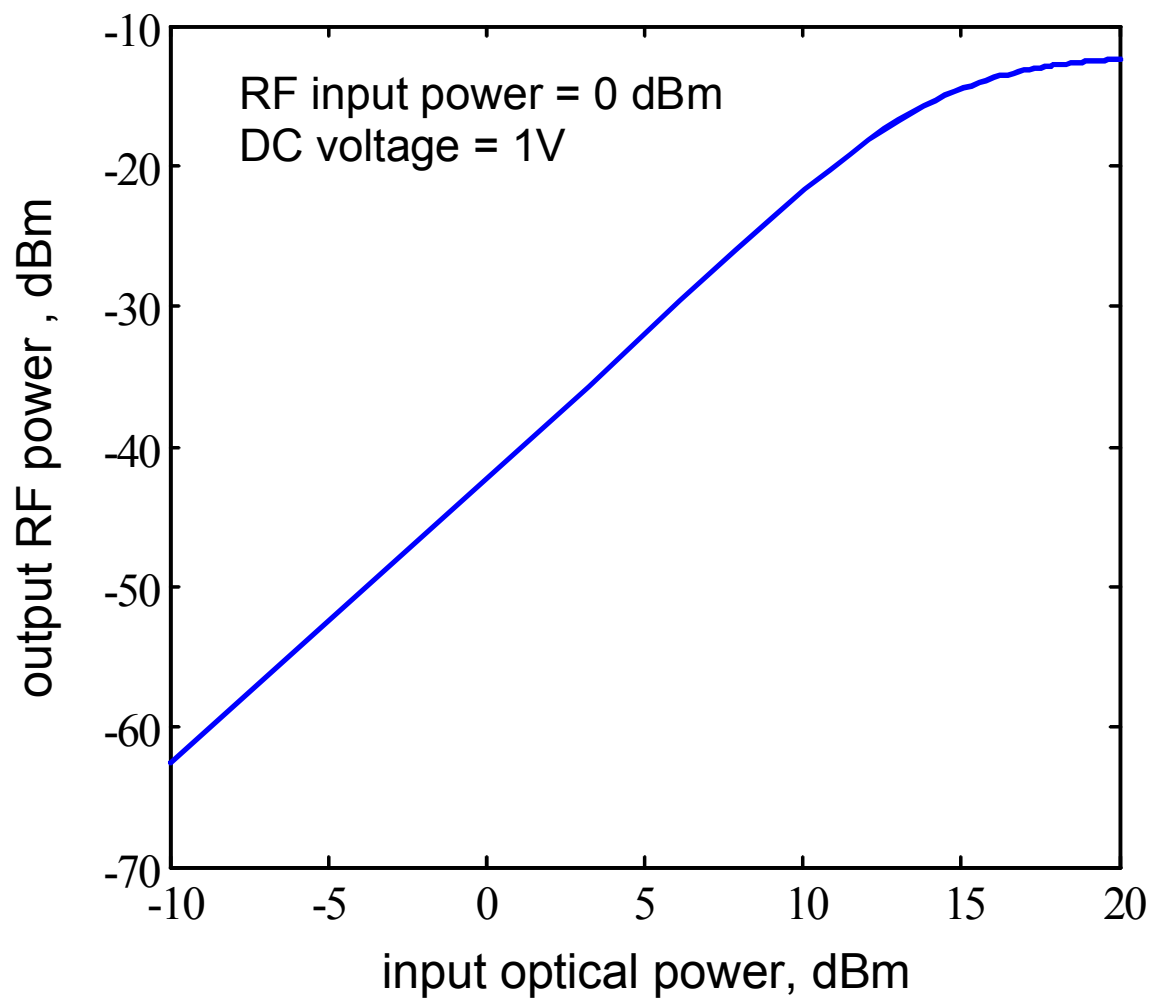
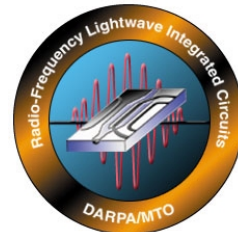
# Saturation and Nonlinear Distortions





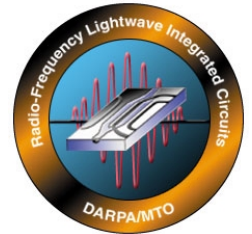


# Optical Power Induced Saturation





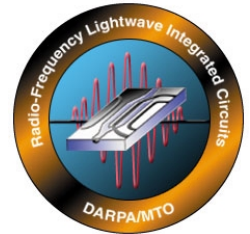
# Directly Modulated RF Lightwave Transmitters



- **Direct modulation of semiconductor laser**  
→ **Compact, simple, low cost**
- **Disadvantages of direct modulation:**
  - Low optical-RF conversion efficiency
  - Bandwidth limited by relaxation oscillation frequency
  - Large nonlinear distortion
  - Chirp
  - High RIN
- **Has been primarily used in low performance systems**



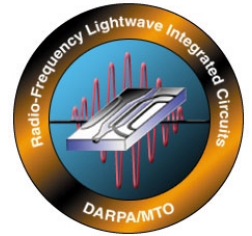
# Directly Modulated Laser with Strong Optical Injection Locking



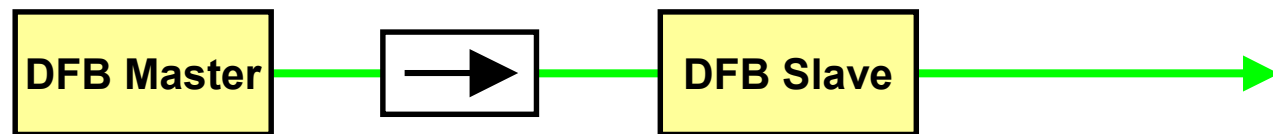
- **Strong optical injection locking** significantly enhance the performance of direct modulation:
  - Increase the modulation bandwidth to beyond the fundamental limit of relaxation oscillation
  - Reduce nonlinear distortions
  - Reduce RIN
  - Reduce chirp
- Enhance the modulation efficiency using gain-lever effect



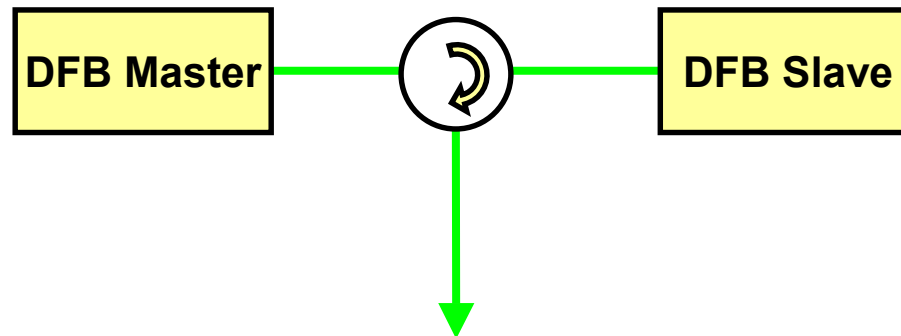
# Injection Locking Set-up

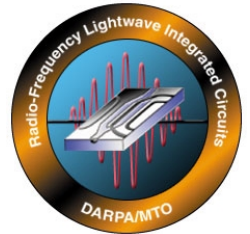


**Transmission  
Type**

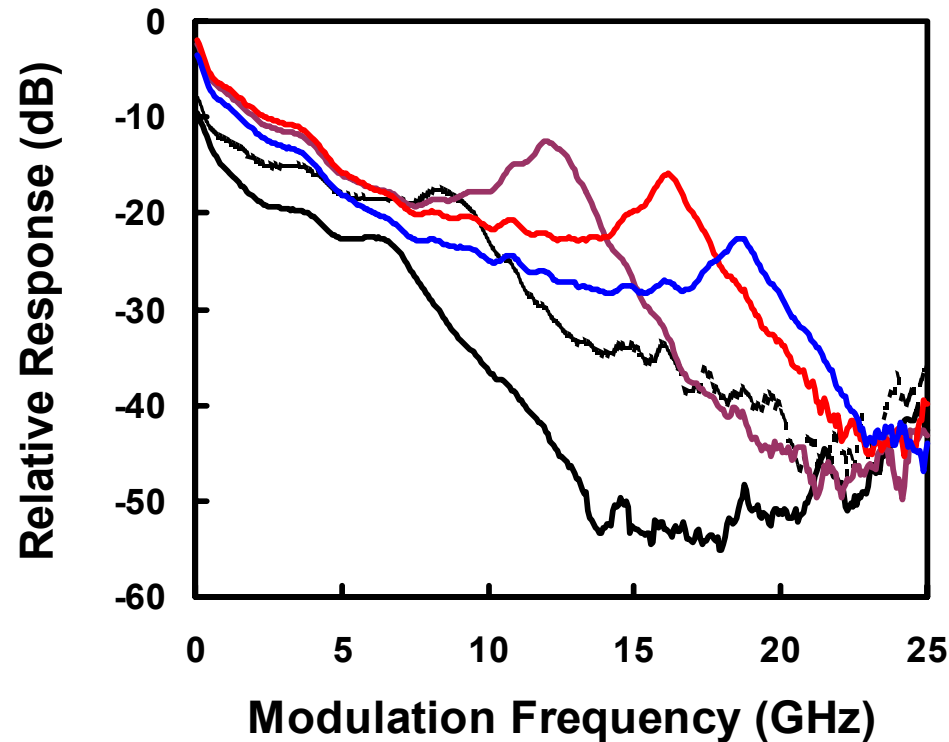


**Reflection  
Type**



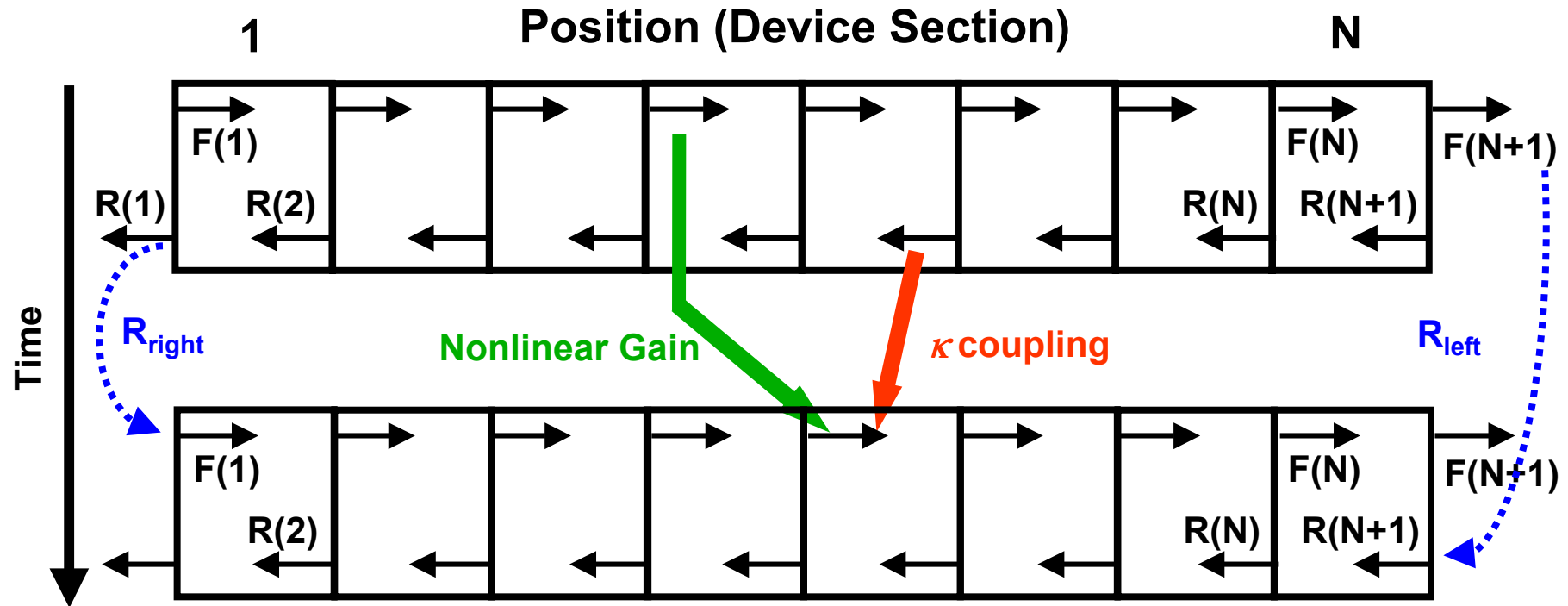


# Modulation Dynamics of Directly Modulated DFB Laser with Strong Optical Injection



- **Enhance modulation bandwidth**
  - *Relaxation oscillation frequency* increased by 4 times
- **Resonant peak height controlled by detuning frequency**

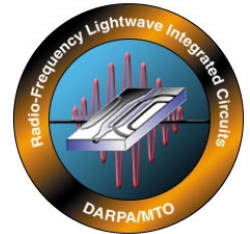
# FDTD Modeling of DFB Lasers



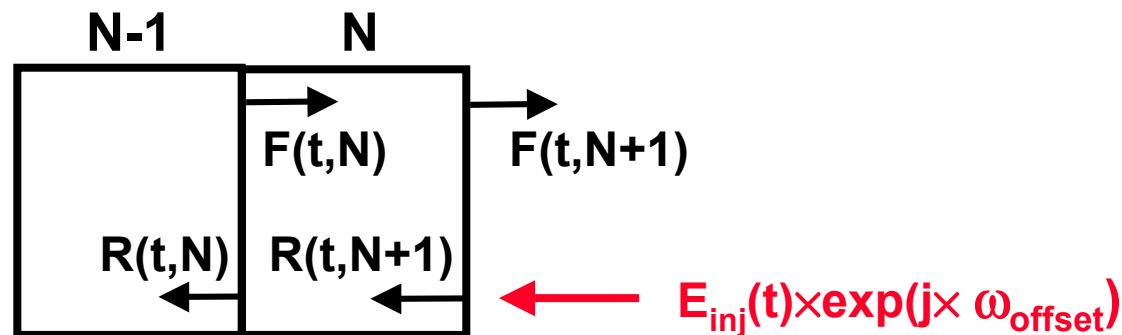
## Coupled Traveling Wave Equations

$$\frac{1}{c_g} \frac{\partial F}{\partial t} + \frac{\partial F}{\partial z} = (g - \alpha_L - i\delta)F + i\kappa R \quad \frac{1}{c_g} \frac{\partial R}{\partial t} - \frac{\partial R}{\partial z} = (g - \alpha_L - i\delta)R + i\kappa F$$

# Modeling Optical Injection Locking Using FDTD Model



## Modified Boundary Conditions



### Injection Ratio:

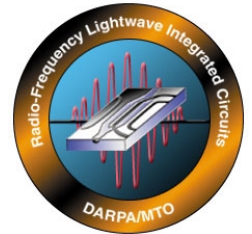
$$\eta = E_{inj} / F(N+1) \text{ (free-running)}$$

### Boundary Conditions:

$$R(t+1, N) = F(t, N+1) \times R_{right}$$

### Boundary Conditions with Optical Injection:

$$R(t+1, n+1) = F(t, n+1) \times R_{right} + E_{inj}(t) \exp(j\omega_{offset})$$



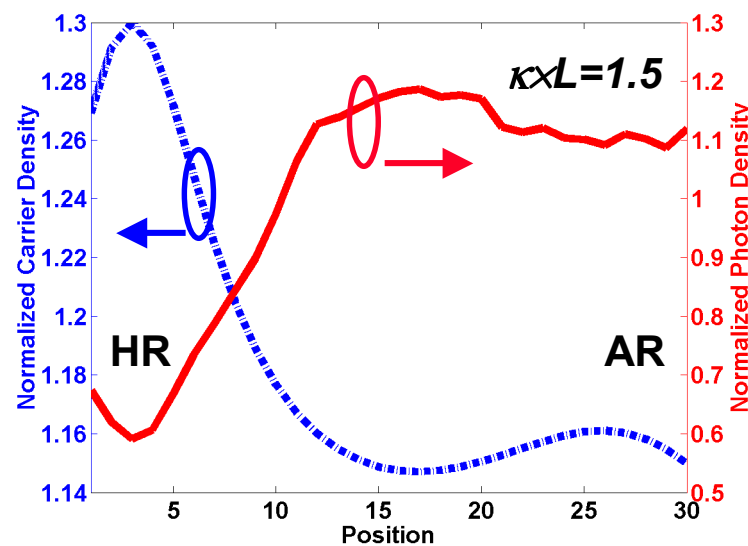
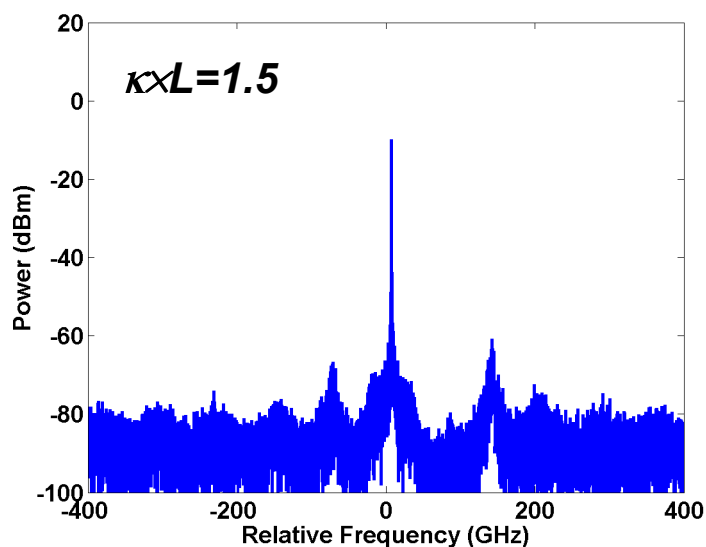
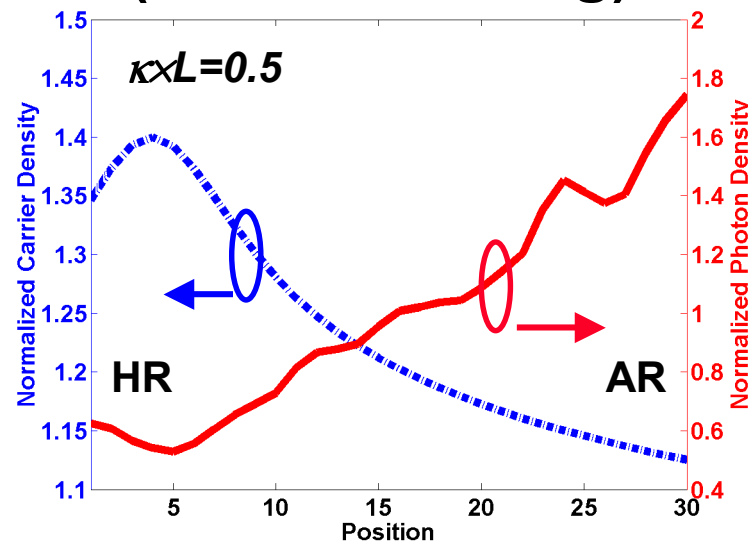
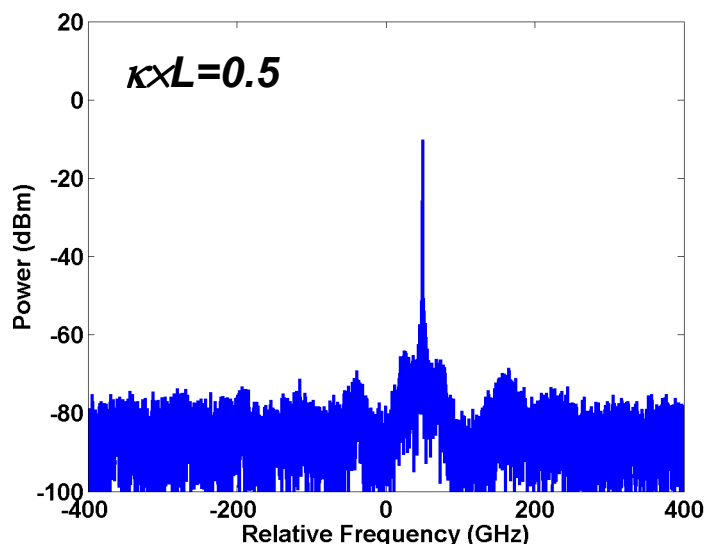
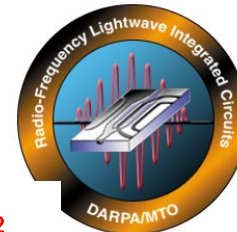
# Advantages of FDTD Modeling of DFB Lasers and Optical Devices

- **Accurately models the non-uniformities in the device**
  - Spatial Hole Burning (SHB)
  - Non-uniform current injection (Split Contact Modulation Techniques)
- **Models the cavity effects**
  - Device characteristics for different  $\kappa L$  products and facet reflectivities
  - Complex coupled DFB lasers can be modeled
- **Multimode model**
  - Takes into account other cavity modes and predicts side-mode suppression
- **Model integrated photonic devices**
  - EML residual reflections at the interfaces

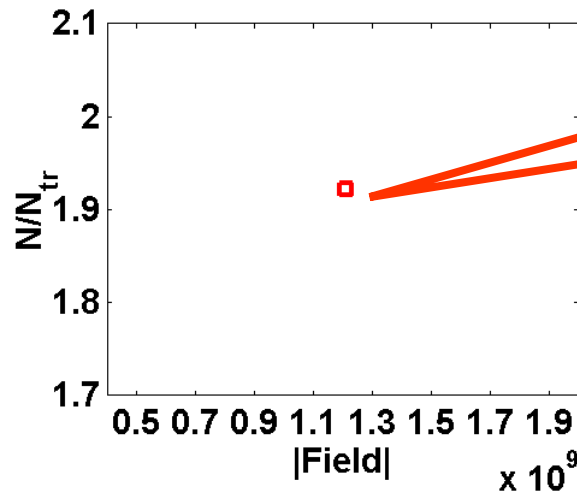
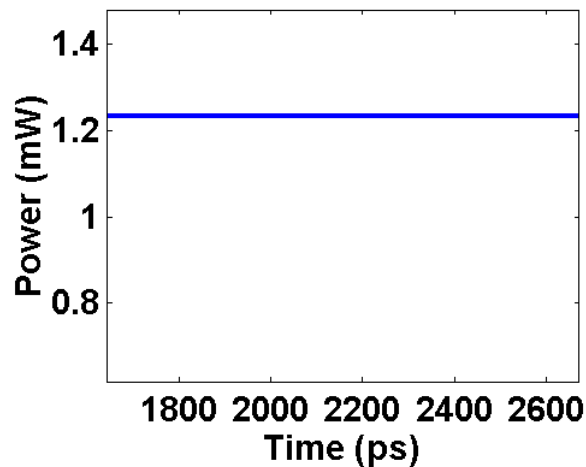
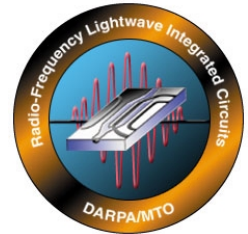




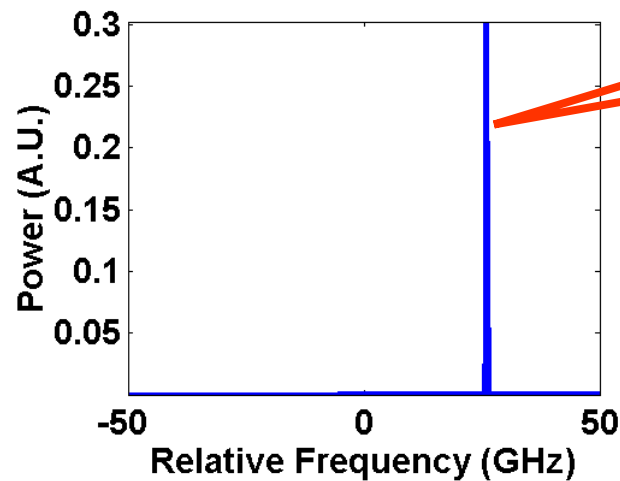
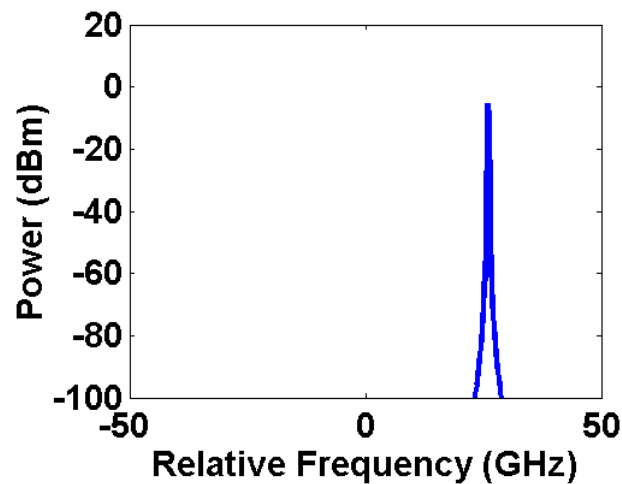
# Simulated Optical Spectrum of DFB Laser for Various $\kappa L$ Products (HR-AR Coating)



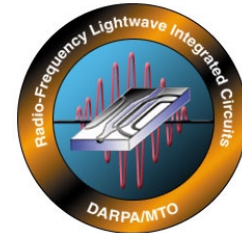
# Stable Injection Locking Laser Dynamics



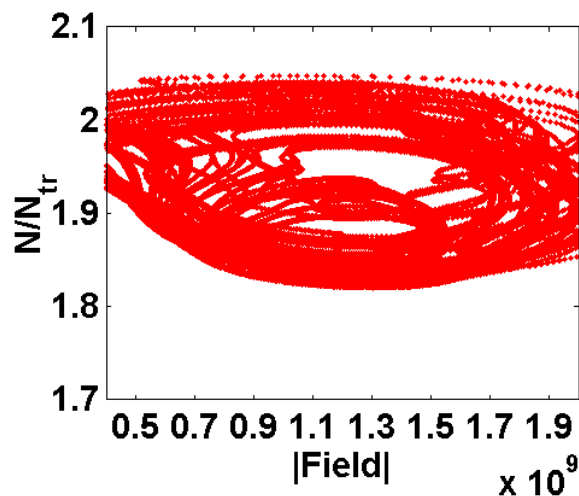
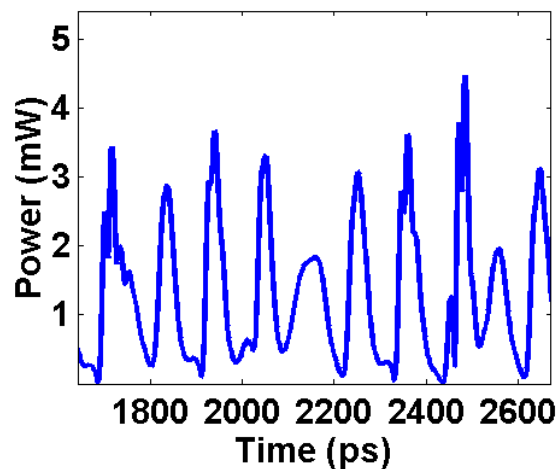
Steady State Field  
and Carrier Density



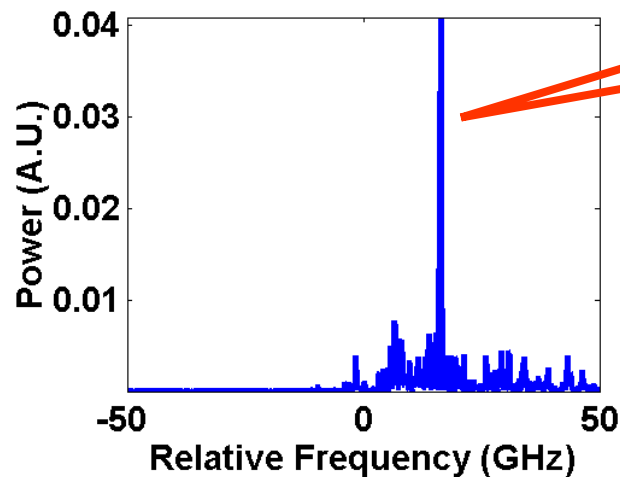
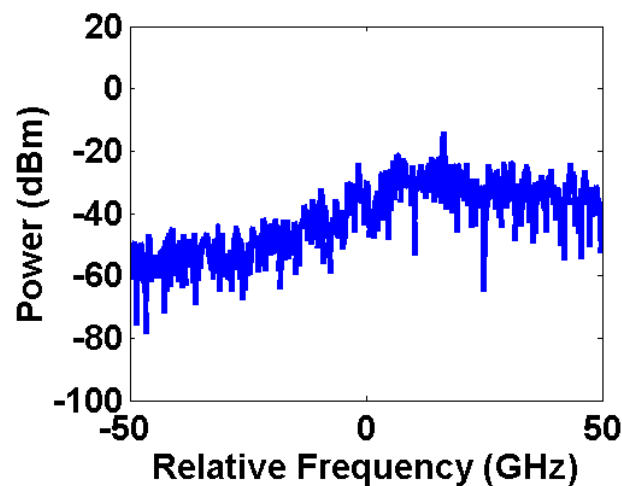
Single Mode  
Optical Spectrum



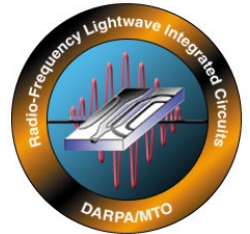
# Chaotic Laser Dynamics Caused by Optical Injection



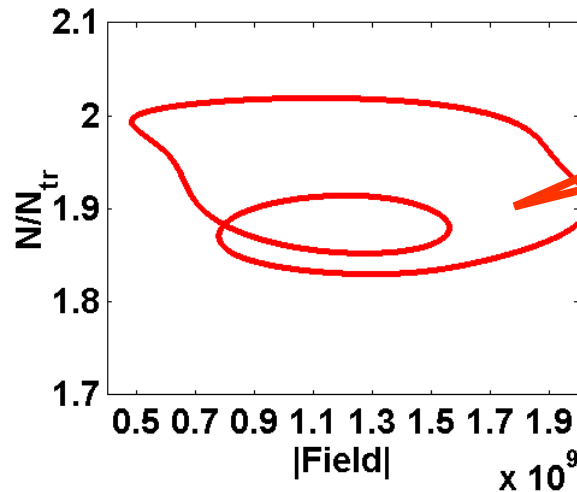
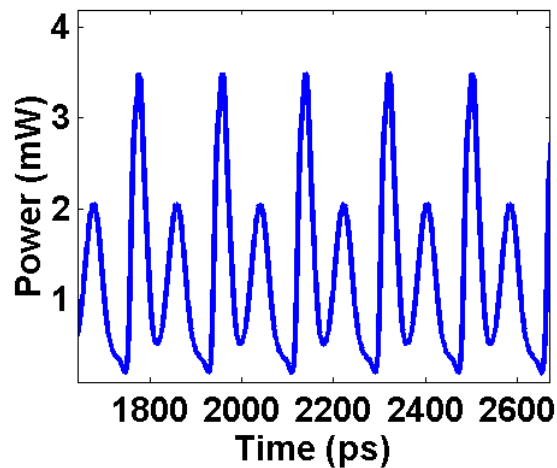
Highly Chaotic State



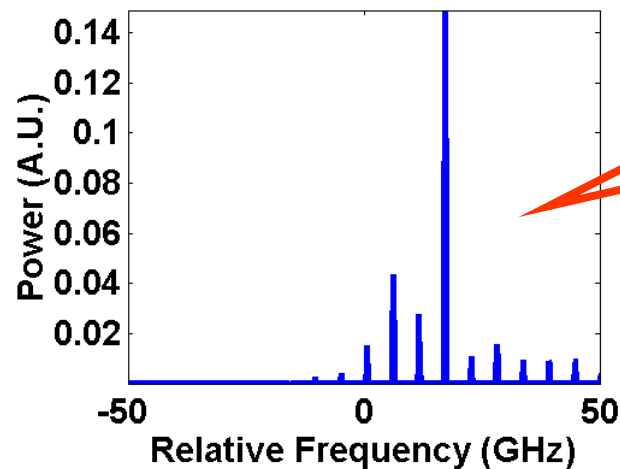
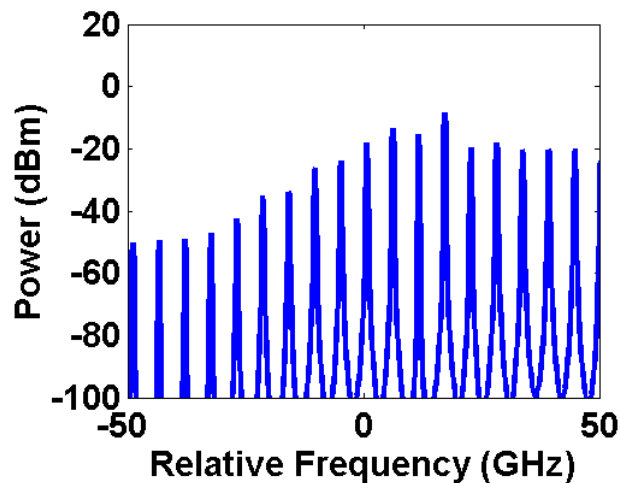
Broadband Optical Spectrum (Noise)



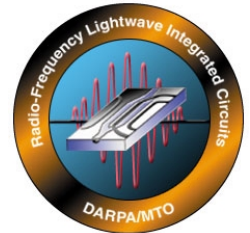
# Periodic Optical Mixing in Semiconductor Lasers (Limit Cycle)



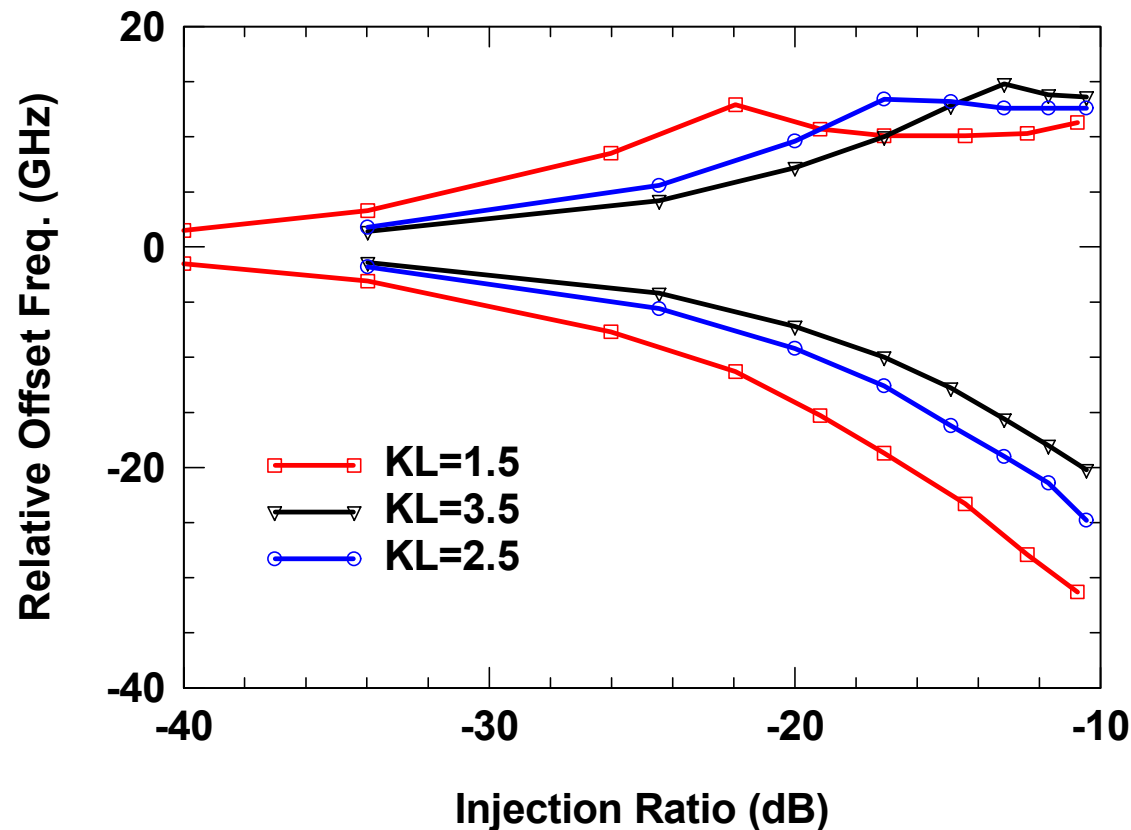
Many possible states  
but predictable



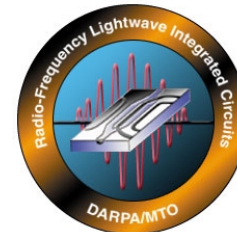
Discrete Optical  
Frequency Spectrum  
(Mixing)



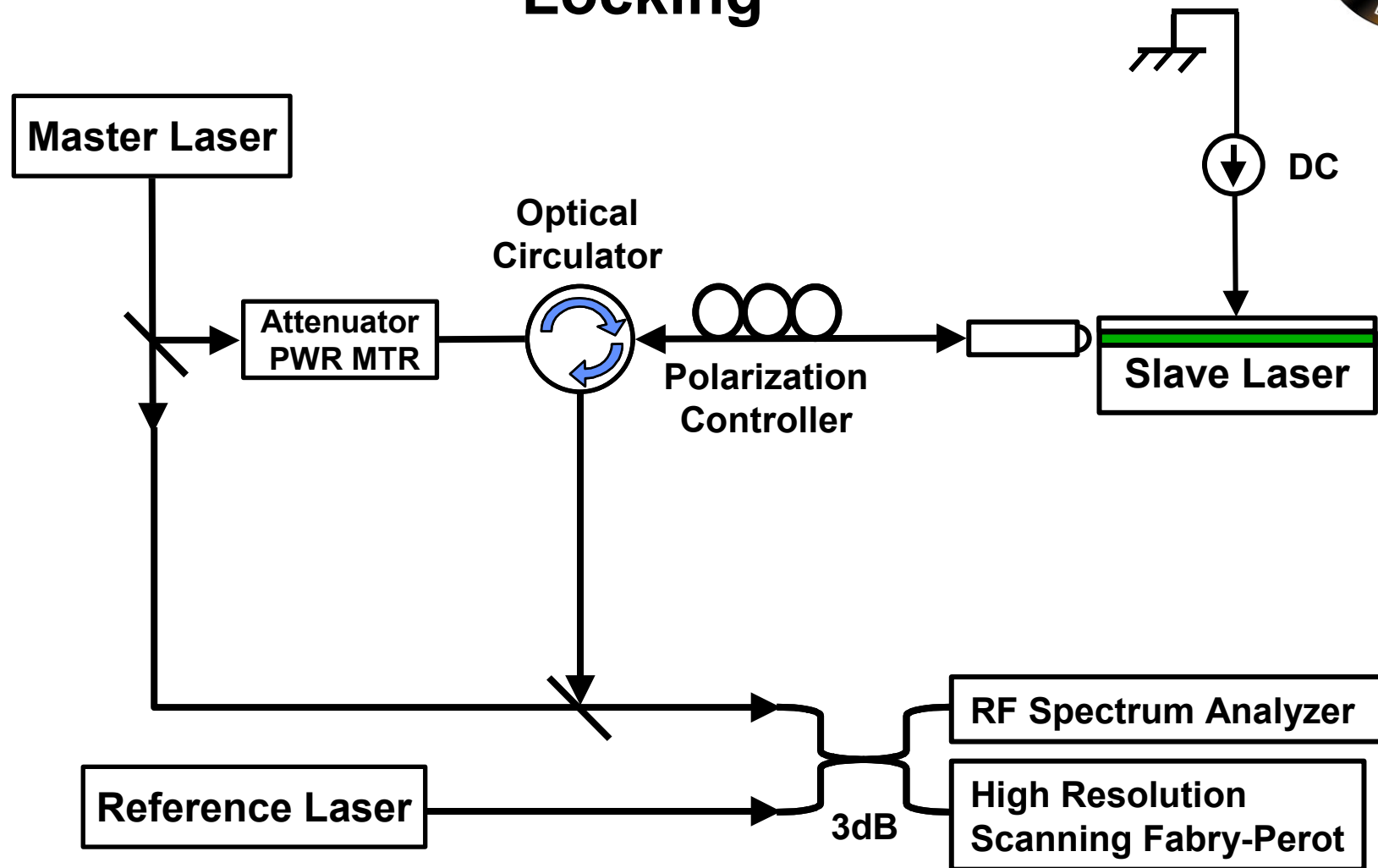
# Simulated Locking Range for Various $K \times L$ Products

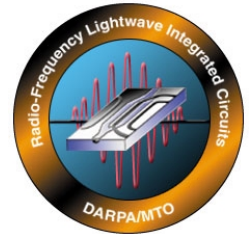


- Locking range is symmetrical at low injection levels
- Size of stable locking range is a strong function of gain saturation



# Experimental Set-up for Optical Injection Locking



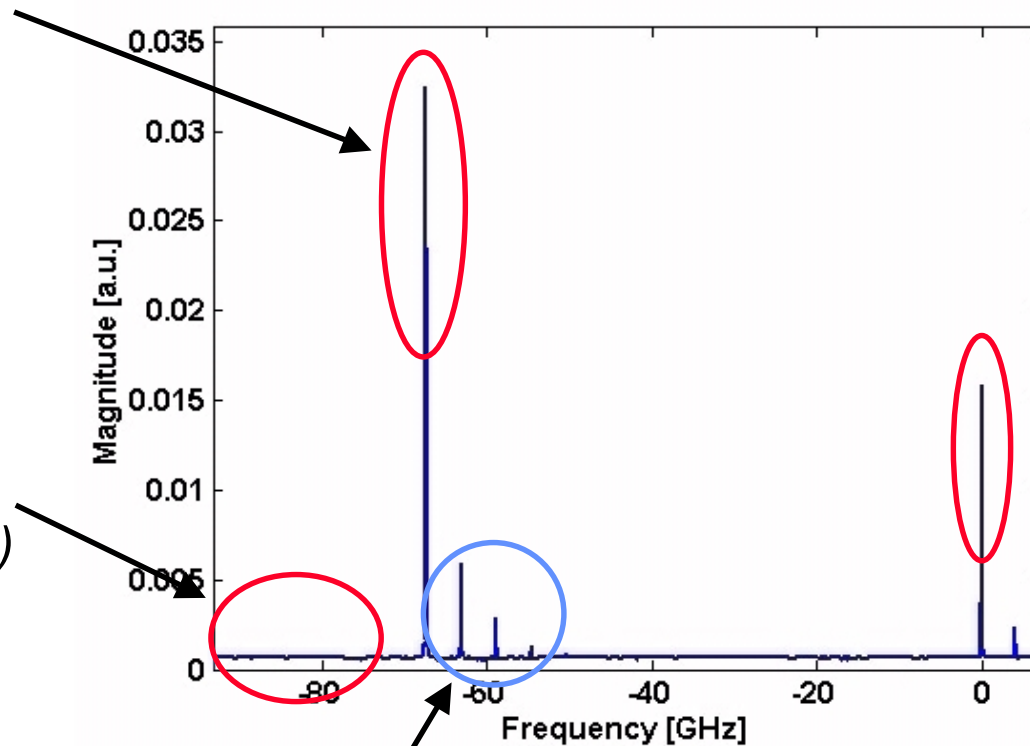


# Injection Locking Visualization

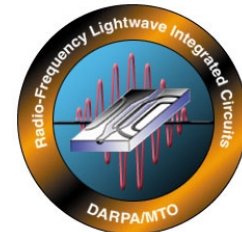
*Slave Laser*

*Reference Laser*

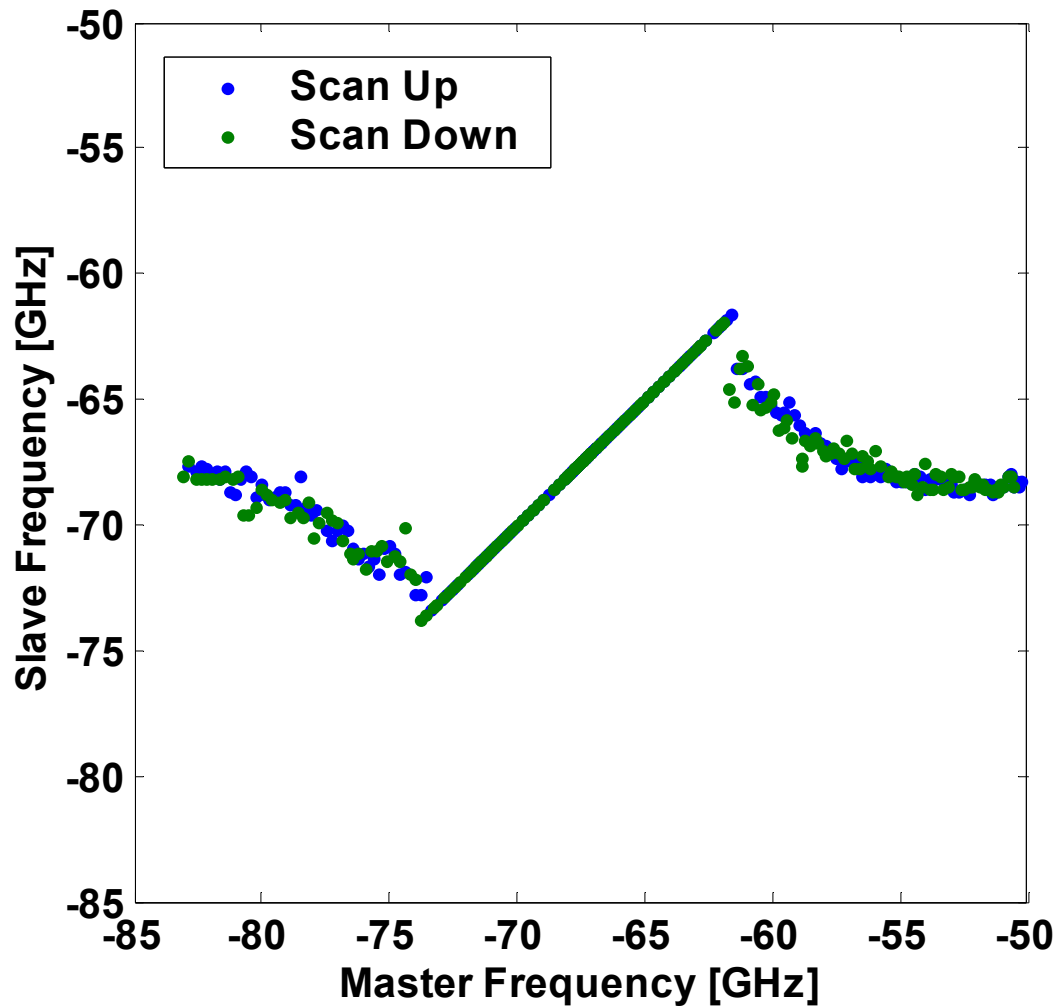
*Master Laser  
(not shown yet)*



*Higher-order  
transverse modes  
of F-P Super Cavity*



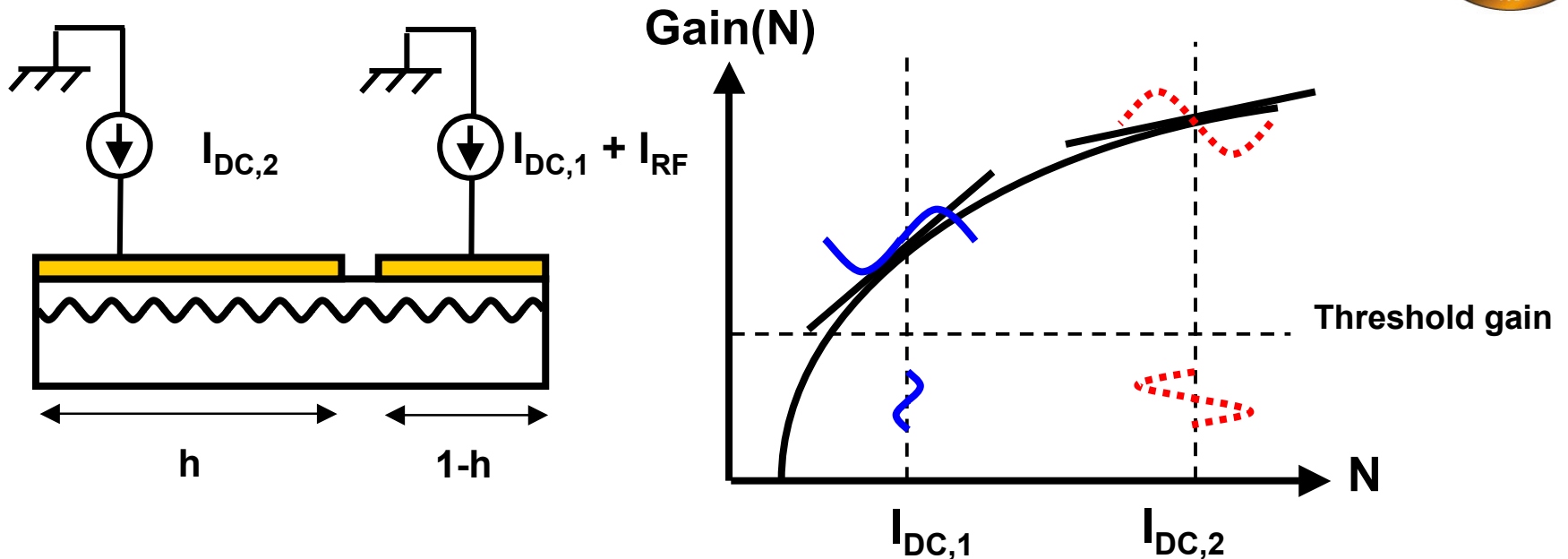
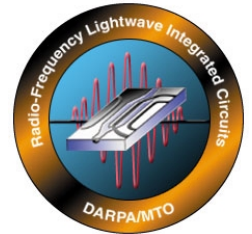
# Locking Range



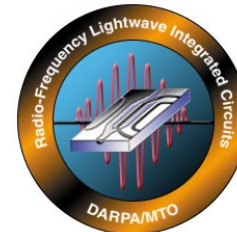




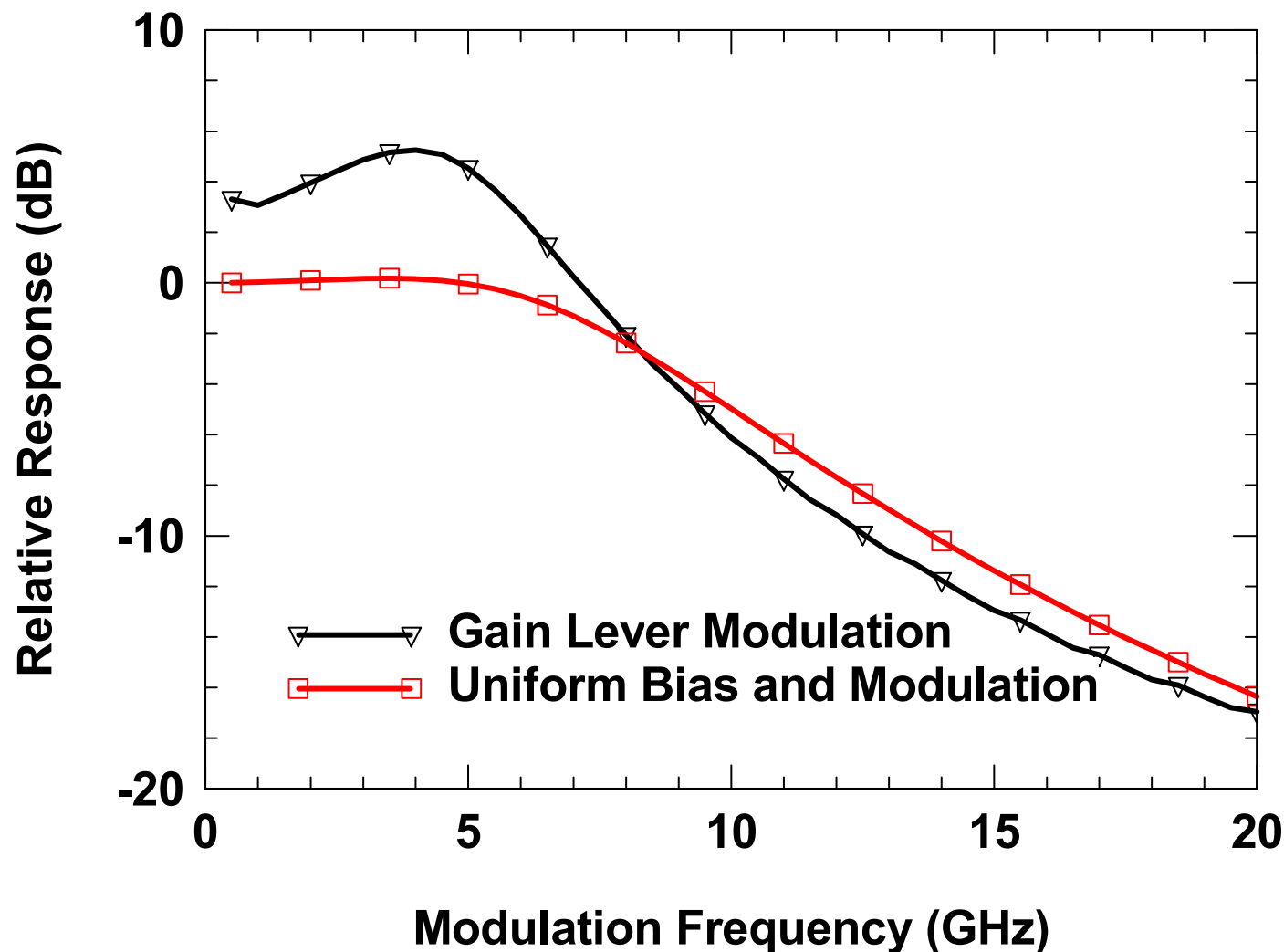
# Gain Lever Modulation Using Semiconductor Lasers

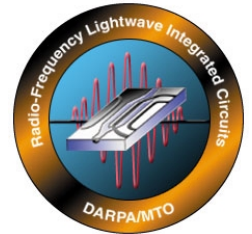


- First demonstrated by Dr. Kam Lau ('89) using FP lasers
- Lasing Condition:  
Total Gain = Gain in Section 1 + Gain in Section 2 = Constant
  - Fabry-Perot laser model, uniform photon and carrier density
  - Lumped element model adequate
- Distributed Feedback Lasers
  - Non-uniform gain due to grating feedback (SHB)
  - Distributed model needed for detailed study



# Simulated Gain Lever Modulation Response (Preliminary Results)





## Conclusion

- Established a **large-signal time-domain model** for traveling-wave EAM
- Developed a comprehensive **FDTD model for directly modulated DFB laser** that is capable of simulating
  - Strong optical injection locking
  - Split-contact modulation
  - Non-uniform photon and carrier distribution in DFB
    - Spatial hole burning, gain saturation, AR-HR coating
  - Nonlinear distortion
  - RIN
- Established an **automated experimental testbed** for characterizing injection-locked lasers
  - Enable us to investigate detailed locking behavior over a wide range of parameter space